

Intel[®] Xeon[™] Processor with 533 MHz Front Side Bus at 2 GHz to 3.20 GHz

Product Features

- Available at 2, 2.40, 2.66, 2.80, 3.06, 3.06
 (1-MB L3 cache), and 3.20 GHz (1-MB and 2-MB L3 cache)
- Dual processing server/workstation support
- Binary compatible with applications running on previous members of Intel's IA32 microprocessor line
- Intel® NetBurstTM micro-architecture
- Hyper-Threading Technology
- Hardware support for multithreaded applications
- 533 MHz Front Side Bus
- Bandwidth up to 4.3 GB/second
- Rapid Execution Engine: Arithmetic Logic Units (ALUs) run at twice the processor core frequency
- Hyper Pipelined Technology
- Advance Dynamic Execution
- Very deep out-of-order execution
- Enhanced branch prediction
- Level 1 Execution Trace Cache stores 12 K micro-ops and removes decoder latency from main execution loops
- Includes 8 KB Level 1 data cache

- 512-KB Advanced Transfer L2 Cache (ondie, full speed Level 2 cache) with 8-way associativity and Error Correcting Code (ECC)
- 1-MB and 2-MB L3 Cache (On-die, full speed Level 3 Cache) with 8-way associativity and Error Correcting Code (ECC)
- Enables system support of up to 64 GB of physical memory
- Streaming SIMD Extensions 2 (SSE2)
- 144 new instructions for double-precision floating point operations, media/video streaming, and secure transactions
- Enhanced floating point and multimedia unit for enhanced video, audio, encryption, and 3D performance
- Power Management capabilities
- System Management mode
- Multiple low-power states
- Advanced System Management Features
- Thermal Monitor
- Machine Check Architecture (MCA)

The Intel® Xeon™ Processor with 533 MHz Front Side Bus is designed for high-performance dual-processor workstation and server applications. Based on the Intel® NetBurst™ microarchitecture and the new Hyper-Threading Technology, it is binary compatible with previous Intel Architecture (IA-32) processors. The Intel Xeon processor with 533 MHz Front Side Bus is scalable to two processors in a multiprocessor system providing exceptional performance for applications running on advanced operating systems such as Windows XP*, Windows* 2000, Linux*, and UNIX*.

The Intel Xeon processor with 533 MHz Front Side Bus delivers compute power at unparalleled value and flexibility for powerful workstations, internet infrastructure, and departmental server applications. The Intel® NetBurstTM microarchitecture and Hyper-Threading Technology deliver outstanding performance and headroom for peak internet server workloads, resulting in faster response times, support for more users, and improved scalability.



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Revision History

Date of Release	Revision No.	Description
November 2002	-001	Initial Release
Fobruary 2002	-002	Added 3.06 GHz information. Edited definitions with current terminology. Added two TDP loadline figures in chapter 6.
February 2003	-002	Edited figures 18 and 19. Added notes to signal definition tables for symmetric agents. Edited Chapter 8.0 Boxed Processor Specifications.
March 2003	-003	Deleted Chapter 3 and Removed Section 2.13, 2.14 Added Table 13
July 2003	-004	Added New Processor - Intel Xeon Processor with 1-MB L3 cache at 3.06GHz
		Updated section 5.1, 5.2.1, and 6.3
September 2003	-005	Updated Figure 3,4, 19, and 20 Added New Processor - Intel Xeon Processor with 1-MB L3 cache at 3.20GHz
Fecruary 2004	-006	Added New Processor - Intel Xeon Processor with 2-MB L3 cache at 3.20GHz Updated Table 6 $\rm I_{\it TCC}$



1.0 Introduction

The Intel® Xeon™ Processor with 533 MHz Front Side Bus is based on the Intel® NetBurst™ micro-architecture, which operates at significantly higher clock speeds and delivers performance levels that are significantly higher than previous generations of IA-32 processors. While based on the Intel NetBurst micro-architecture, it maintains the tradition of compatibility with IA-32 software.

The Intel NetBurst micro-architecture features begin with innovative techniques that enhance processor execution such as Hyper Pipelined Technology, a Rapid Execution Engine, Advanced Dynamic Execution, enhanced Floating Point and Multimedia unit, and Streaming SIMD Extensions 2 (SSE2). The Hyper Pipelined Technology doubles the pipeline depth in the processor, allowing the processor to reach much higher core frequencies. The Rapid Execution Engine allows the two integer ALUs in the processor to run at twice the core frequency, which allows many integer instructions to execute in one half of the internal core clock period. The Advanced Dynamic Execution improves speculative execution and branch prediction internal to the processor. The floating point and multi-media units have been improved by making the registers 128 bits wide and adding a separate register for data movement. Finally, SSE2 adds 144 new instructions for double-precision floating point, SIMD integer, and memory management for improvements in video/ multimedia processing, secure transactions, and visual internet applications.

Also part of the Intel NetBurst micro-architecture, the front side bus and caches on the Intel Xeon processor with 533 MHz Front Side Bus provide tremendous throughput for server and workstation workloads. The 533 MHz Front Side Bus provides a high-bandwidth pipeline to the system memory and I/O. It is a quad-pumped bus running off a 133 MHz Front Side Bus clock making 4.3 Gigabytes per second (4,300 Megabytes per second) data transfer rates possible. The Execution Trace Cache is a level 1 cache that stores approximately twelve thousand decoded micro-operations, which removes the decoder latency from the main execution path and increases performance. The Advanced Transfer Cache is a 512 KB on-die level 2 cache running at the speed of the processor core providing increased bandwidth over previous micro-architectures. The Intel® XeonTM Processor with 533 MHz Front Side Bus also has 1-MB and 2-MB on-die, full speed level 3 cache¹ with 8-way associativity and Error Correcting Code (ECC).

In addition to the Intel NetBurst micro-architecture, the Intel Xeon processor with 533 MHz Front Side Bus includes a groundbreaking new technology called Hyper-Threading technology, which enables multi-threaded software to execute tasks in parallel within the processor resulting in a more efficient, simultaneous use of processor resources. Server applications can realize increased performance from Hyper-Threading technology today, while workstation applications are expected to benefit from Hyper-Threading technology in the future through software and processor evolution. The combination of Intel NetBurst micro-architecture and Hyper-Threading technology delivers outstanding performance, throughput, and headroom for peak software workloads resulting in faster response times and improved scalability.

The Intel Xeon processor with 533 MHz Front Side Bus is intended for high performance workstation and server systems with up to two processors on a single bus. The processor supports both uniand dual-processor designs. The Intel Xeon with 533 MHz Front Side Bus processors do not incorporate system managment devices (PIROM, OEM Scratchpad EEPROM, and thermal sensor), but offer direct access to the pins of an on-die thermal diode. These output pins can interface with a thermal sensor device that is placed on the baseboard. The Intel Xeon processor with 533 MHz Front Side Bus is packaged in a 604-pin flip chip micro-PGA2 (FC-mPGA2) package, and utilizes a surface mount ZIF socket with 604 pins.

The FC-mPGA2 package contains an extra pin (located at location AE30) compared to the INT-



mPGA package. This additional pin serves as a keying mechanism to prevent the FC-mPGA2 package from being installed in the 603-pin socket since processors in the FC-mPGA2 package are only supported in the 604-pin socket. Since the additional contact for pin AE30 is electrically inert, the 604-pin socket will not have a solder ball at this location.

Mechanical components used for attaching thermal solutions to the baseboard should have a high degree of commonality with the thermal solution components enabled for the Intel Xeon processor Heatsinks and retention mechanisms have been designed with manufacturability as a high priority. Hence, mechanical assembly can be completed from the top of the baseboard.

The Intel Xeon processor with 533 MHz Front Side Bus uses a scalable front side bus protocol referred to as the "Front Side Bus" in this document. The processor front side bus utilizes a splittransaction, deferred reply protocol similar to that introduced by the Pentium® Pro processor Front Side Bus, but is not compatible with the Pentium Pro processor front side bus. The Intel Xeon processor with 533 MHz Front Side Bus is compatible with the Intel Xeon processor Front Side Bus. The front side bus uses Source-Synchronous Transfer (SST) of address and data to improve performance, and transfers data four times per bus clock (4X data transfer rate). Along with the 4X data bus, the address bus can deliver addresses two times per bus clock and is referred to as a 'double-clocked' or 2X address bus. In addition, the Request Phase completes in one clock cycle. Working together, the 4X data bus and 2X address bus provide a data bus bandwidth of up to 4.3 Gigabytes per second. Finally, the front side bus also introduces transactions that are used to deliver interrupts.

Signals on the front side bus use Assisted GTL+ (AGTL+) level voltages which are fully described in the appropriate platform design guide (refer to Section 1.3).

NOTE

1. Refers to The Intel[®] XeonTM Processor with 1-MB and 2-MB L3 cache at 3.06 and 3.20 GHz.

1.1 Terminology

A '#' symbol after a signal name refers to an active low signal, indicating a signal is in the asserted state when driven to a low level. For example, when RESET# is low, a reset has been requested. Conversely, when NMI is high, a nonmaskable interrupt has occurred. In the case of signals where the name does not imply an active state but describes part of a binary sequence (such as *address* or *data*), the '#' symbol implies that the signal is inverted. For example, D[3:0] = 'HLHL' refers to a hex 'A', and D[3:0]# = 'LHLH' also refers to a hex 'A' (H= High logic level, L= Low logic level).

Front Side Bus (FSB): The electrical interface that connects the processor to the chipset. Also referred to as the processor system bus or the system bus. All memory and I/O transactions as well as interrupt messages pass between the processor and chipset over the FSB.

1.1.1 Processor Packaging Terminology

Commonly used terms are explained here for clarification:

• **604-pin socket** - The 604-pin socket contains an additional contact to accept the additional keying pin on the Intel Xeon processor in the FC-mPGA2 packages at pin location AE30. The 604-pin socket will also accept processors with the INT-mPGA package. Since the additional contact for pin AE30 is electrically inert, the 604-pin socket will not have a solder ball at this location. Therefore, the additional keying pin will not require a baseboard via nor a surface-mount pad. See the *mPGA604 Socket Design Guidelines* for details regarding this socket.



- Central Agent The central agent is the host bridge to the processor and is typically known as the chipset.
- Flip Chip Ball Grid Array (FC-BGA) Microprocessor packaging using "flip chip" design, where the processor is attached to the substrate face-down for better signal integrity, more efficient heat removal and lower inductance
- FC-mPGA2 Packaging technology with the processor die mounted directly to a micro-Pin Grid Array substrate with an integrated heat spreader (IHS).
- Front Side Bus Front Side Bus (FSB) is the electrical interface that connects the processor to the chipset. Also referred to as the processor system bus or the system bus. All memory and I/O transactions as well as interrupt messages pass between the processor and chipset over the FSB.
- Intel[®] Xeon[™] processor with 512 KB L2 cache The entire processor in its INT-mPGA package, including processor core in its FC-BGA package, integrated heat spreader (IHS), and interposer.
- Intel[®] XeonTM processor with 533 MHz Front Side Bus The entire processor in its FC-mPGA2 package, including processor core in its FC-BGA package, integrated heat spreader (IHS), and interposer.
- Integrated Heat Spreader (IHS) The surface used to attach a heatsink or other thermal solution to the processor.
- Interposer The structure on which the processor core package and I/O pins are mounted.
- **OEM** Original Equipment Manufacturer.
- **Processor core** The processor's execution engine. All AC timing and signal integrity specifications are to the pads of the processor core.
- **Retention mechanism** The support components that are mounted through the baseboard to the chassis to provide mechanical retention for the processor and heatsink assembly.
- Symmetric Agent A symmetric agent is a processor which shares the same I/O subsystem and memory array, and runs the same operating system as another processor in a system. Systems using symmetric agents are known as Symmetric Multiprocessing (SMP) systems. Intel[®] XeonTM (DP Dual Processor) processors should only be used in SMP systems which have two or fewer symmetric agents.

1.2 State of Data

The data contained in this document is subject to change. It is the best information that Intel is able to provide at the publication date of this document.



1.3 References

The reader of this specification should also be familiar with material and concepts presented in the following documents:

Document	Intel Order Number ¹
AP-485, Intel® Processor Identification and the CPUID Instruction	241618
IA-32 Intel ® Architecture Software Developer's Manual	
Volume I: Basic Architecture	245470
Volume II: Instruction Set Reference	245471
Volume III: System Programming Guide	245472
Intel ® Xeon TM Processor with 512-KB L2 Cache and Intel [®] E7505 Chipset Platform Design Guide	http://developer.intel.com
Intel® Xeon™ Processor Thermal Design Guidelines	298348
603 -Pin Socket Design Guidelines	249672
Intel® Xeon™ Processor Specification Update	249678
CK00 Clock Synthesizer/Driver Design Guidelines	249206
VRM 9.0 DC-DC Converter Design Guidelines	249205
VRM 9.1 DC-DC Converter Design Guidelines	298646
Dual Intel® Xeon™ Processor Voltage Regulator Down (VRD) Design Guidelines	298644
ITP700 Debug Port Design Guide	249679
Intel® Xeon™ Processor with 533 MHz Front Side Bus System Compatibility Guidelines	
Intel® Xeon™ Processor with 533 MHz Front Side Bus Signal Integrity Models	http://developer.intel.com
Intel® Xeon™ Processor with 533 MHz Front Side Bus Mechanical Models in ProE* Format	http://developer.intel.com
IIntel® Xeon™ Processor with 533 MHz Front Side Bus Mechanical Models in IGES* Format	http://developer.intel.com
Intel® Xeon™ Processor with 512-KB L2 Cache Front Side Bus Thermal Models (FloTherm* and ICEPAK* format)	http://developer.intel.com
Intel® Xeon™ Processor with 533 MHz Front Side Bus Core Boundary Scan Descriptor Language (BSDL) Model	http://developer.intel.com
Wired for Management 2.0 Design Guide	http://developer.intel.com
Boxed Integration Notes	http://support.intel.com/ support/processors/xeon

NOTES

2. Contact your Intel representative for the latest revision of documents without order numbers.



2.0 Electrical Specifications

2.1 Front Side Bus and GTLREF

Most Intel® XeonTM Processor with 533MHz Front Side Bus signals use Assisted Gunning Transceiver Logic (AGTL+) signaling technology. This signaling technology provides improved noise margins and reduced ringing through low voltage swings and controlled edge rates. The processor termination voltage level is V_{CC} , the operating voltage of the processor core. The use of a termination voltage that is determined by the processor core allows better voltage scaling on the processor front side bus. Because of the speed improvements to data and address busses, signal integrity and platform design methods become more critical than with previous processor families. Front side bus design guidelines are detailed in the appropriate platform design guide (refer to Section 1.3).

The AGTL+ inputs require a reference voltage (GTLREF) which is used by the receivers to determine if a signal is a logical 0 or a logical 1. GTLREF must be generated on the baseboard (See Table 12 for GTLREF specifications). Termination resistors are provided on the processor silicon and are terminated to its core voltage ($V_{\rm CC}$). The on-die termination resistors are a selectable feature and can be enabled or disabled via the ODTEN pin. For end bus agents, on-die termination can be enabled to control reflections on the transmission line. For middle bus agents, on-die termination must be disabled. Intel chipsets will also provide on-die termination, thus eliminating the need to terminate the bus on the baseboard for most AGTL+ signals. Refer to Section 2.12 for details on ODTEN resistor termination requirements.

Note: Some AGTL+ signals do not include on-die termination and must be terminated on the baseboard. See Table 4 for details regarding these signals.

The AGTL+ signals depend on incident wave switching. Therefore timing calculations for AGTL+ signals are based on flight time as opposed to capacitive deratings. Analog signal simulation of the front side bus, including trace lengths, is highly recommended when designing a system. Please refer to http://developer.intel.com to obtain the Intel[®] XeonTM Processor with 533 MHZ Front Side Bus Signal Integrity Models.

2.2 Power and Ground Pins

For clean on-chip power distribution, the Intel Xeon processor with 533 MHz Front Side Bus has 190 V_{CC} (power) and 189 V_{SS} (ground) inputs. All V_{CC} pins must be connected to the system power plane, while all V_{SS} pins must be connected to the system ground plane. The processor V_{CC} pins must be supplied the voltage determined by the processor VID (Voltage ID) pins.

2.3 Decoupling Guidelines

Due to its large number of transistors and high internal clock speeds, the processor is capable of generating large average current swings between low and full power states. This may cause voltages on power planes to sag below their minimum values if bulk decoupling is not adequate. Larger bulk storage (C_{BULK}), such as electrolytic capacitors, supply current during longer lasting changes in current demand by the component, such as coming out of an idle condition. Similarly, they act as a storage well for current when entering an idle condition from a running condition.



Care must be taken in the baseboard design to ensure that the voltage provided to the processor remains within the specifications listed in Table 6. Failure to do so can result in timing violations or reduced lifetime of the component. For further information and guidelines, refer to the appropriate platform design guidelines.

2.3.1 V_{CC} Decoupling

Regulator solutions need to provide bulk capacitance with a low Effective Series Resistance (ESR) and the baseboard designer must ensure a low interconnect resistance from the regulator (or VRM pins) to the 604-pin socket. Bulk decoupling may be provided on the voltage regulation module (VRM) to meet help meet the large current swing requirements. The remaining decoupling is provided on the baseboard. The power delivery path must be capable of delivering enough current while maintaining the required tolerances (defined in Table 6). For further information regarding power delivery, decoupling, and layout guidelines, refer to the appropriate platform design guidelines.

2.3.2 Front Side Bus AGTL+ Decoupling

The Intel[®] XeonTM processor with 533MHz Front Side Bus integrates signal termination on the die as well as part of the required high frequency decoupling capacitance on the processor package. However, additional high frequency capacitance must be added to the baseboard to properly decouple the return currents from the front side bus. Bulk decoupling must also be provided by the baseboard for proper AGTL+ bus operation. Decoupling guidelines are described in the appropriate platform design guidelines.

2.4 Front Side Bus Clock (BCLK[1:0]) and Processor Clocking

BCLK[1:0] directly controls the front side bus interface speed as well as the core frequency of the processor. As in previous generation processors, the processor core frequency is a multiple of the BCLK[1:0] frequency. The maximum processor bus ratio multiplier will be set during manufacturing. The default setting will equal the maximum speed for the processor.

The BCLK[1:0] inputs directly control the operating speed of the front side bus interface. The processor core frequency is configured during reset by using values stored internally during manufacturing. The stored value sets the highest bus fraction at which the particular processor can operate.

Clock multiplying within the processor is provided by the internal PLL, which requires a constant frequency BCLK[1:0] input with exceptions for spread spectrum clocking. Processor DC and AC specifications for the BCLK[1:0] inputs are provided in Table 7 and Table 13, respectively. These specifications must be met while also meeting signal integrity requirements as outlined in Chapter 3.0. The processor utilizes a differential clock. Details regarding BCLK[1:0] driver specifications are provided in the *CK408 Clock Synthesizer/Driver Design Guidelines*.. Table 1 contains the supported bus fraction ratios and their corresponding core frequencies.



Table 1. Front Side Bus-to-Core Frequency Ratio

Front Side Bus-to-Core Frequency Ratio	Core Frequency
1/15	2 GHz
1/18	2.40 GHz
1/20	2.66 GHz
1/21	2.80 GHz
1/23	3.06 GHz
1/25	3.20 GHz

2.4.1 Bus Clock

The front side bus frequency is set to the maximum supported by the individual processor. BSEL[1:0] are outputs used to select the front side bus frequency. Table 2 defines the possible combinations of the signals and the frequency associated with each combination. The frequency is determined by the processor(s), chipset, and clock synthesizer. All front side bus agents must operate at the same frequency. Individual processors will only operate at their specified front side bus clock frequency, (100 MHz for present generation processors).

The Intel® Xeon TM processor with a 533 MHz Front Side Bus is designed to run on a baseboard with a 133 MHz bus clock. On these baseboards, BSEL[0:1] are considered 'reserved' at the processor socket.

Table 2. Front Side Bus Clock Frequency Select Truth Table for BSEL[1:0]

BSEL1	BSEL0	Bus Clock Frequency
L	L	100 MHz
L	Н	133 MHz
Н	L	Reserved
Н	Н	Reserved

2.5 PLL Filter

 V_{CCA} and V_{CCIOPLL} are power sources required by the processor PLL clock generator. This requirement is identical to that of the Intel Xeon processor with 512-KB L2 cache. Since these PLLs are analog in nature, they require quiet power supplies for minimum jitter. Jitter is detrimental to the system: it degrades external I/O timings as well as internal core timings (i.e. maximum frequency). To prevent this degradation, these supplies must be low pass filtered from V_{CC} . A typical filter topology is shown in Figure 1.

The AC low-pass requirements, with input at V_{CC} and output measured across the capacitor (C_A or C_{IO} in Figure 1), is as follows:

- < 0.2 dB gain in pass band
- < 0.5 dB attenuation in pass band < 1 Hz (see DC drop in next set of requirements)
- > 34 dB attenuation from 1 MHz to 66 MHz

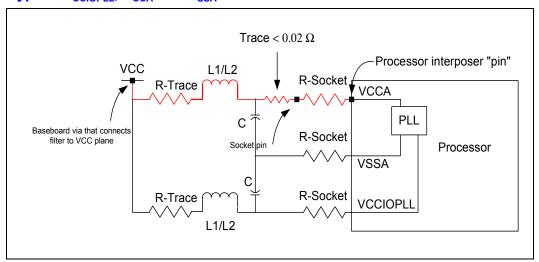
Datasheet 13



• > 28 dB attenuation from 66 MHz to core frequency

The filter requirements are illustrated in Figure 2. For recommendations on implementing the filter refer to the appropriate platform design guidelines.

Figure 1. Typical V_{CCIOPLL} , V_{CCA} and V_{SSA} Power Distribution





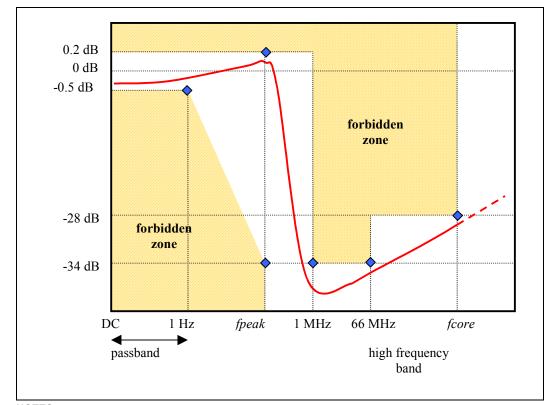


Figure 2. Phase Lock Loop (PLL) Filter Requirements

NOTES:

- 1. Diagram not to scale.
- 2. No specifications for frequencies beyond f_{core} (core frequency).
- 3. f_{peak}, if existent, should be less than 0.05 MHz.

2.5.1 Mixing Processors

Intel only supports those processor combinations operating with the same front side bus frequency, core frequency, VID settings, and cache sizes. Not all operating systems can support multiple processors with mixed frequencies. Intel does not support or validate operation of processors with different cache sizes. Mixing processors of different steppings but the same model (as per CPUID instruction) is supported, and is outlined in the *Intel® XeonTM Processor Specification Update*. Additional details are provided in AP-485, the *Intel Processor Identification and the CPUID Instruction* application note.

The Intel Xeon processor with 533 MHz Front Side Bus does not sample the pins IGNNE#, LINT[0]/INTR, LINT[1]/NMI, and A20M# to establish the core to front side bus ratio. Rather, the processor runs at its tested frequency at initial power-on. If the processor needs to run at a lower core frequency, as must be done when a higher speed processor is added to a system that contains a lower frequency processor, the system BIOS is able to effect the change in the core to front side bus ratio.



2.6 Voltage Identification

The VID specification for the processor is defined in this datasheet, and is supported by power delivery solutions designed according to the *Dual Intel® Xeon TM Processor Voltage Regulator Down (VRD) Design Guidelines, VRM 9.0 DC-DC Converter Design Guidelines,* and *VRM 9.1 DC-DC Converter Design Guidelines.* The minimum voltage is provided in Table 6, and varies with processor frequency. This allows processors running at a higher frequency to have a relaxed minimum voltage specification. The specifications have been set such that one voltage regulator design can work with all supported processor frequencies.

Note that the VID pins will drive valid and correct logic levels when the Intel[®] $Xeon^{TM}$ processor with 533 MHz Front Side Bus is provided with a valid voltage applied to the SM_V_{CC} pins. VID_V_{CC} must be correct and stable prior to enabling the output of the VRM that supplies V_{CC} . Similarly, the output of the VRM must be disabled before VID_V_{CC} becomes invalid. Refer to Figure 17 for details.

The processor uses five voltage identification pins, VID[4:0], to support automatic selection of processor voltages. Table 3 specifies the voltage level corresponding to the state of VID[4:0]. A '1' in this table refers to a high voltage and a '0' refers to low voltage level. If the processor socket is empty (VID[4:0] = 11111), or the VRD or VRM cannot supply the voltage that is requested, it must disable its voltage output. For further details, see the *Dual Intel® XeonTM Processor Voltage Regulator Down (VRD) Design Guidelines, or VRM 9.0 DC-DC Converter Design Guidelines* or the *VRM 9.1 DC-DC Converter Design Guidelines*.



Table 3. Voltage Identification Definition

Processor Pins								
VID4	VID3	VID2	VID1	VID0	V _{CC_VID} (V)			
1	1	1	1	1	VRM output off			
1	1	1	1	0	1.100			
1	1	1	0	1	1.125			
1	1	1	0	0	1.150			
1	1	0	1	1	1.175			
1	1	0	1	0	1.200			
1	1	0	0	1	1.225			
1	1	0	0	0	1.250			
1	0	1	1	1	1.275			
1	0	1	1	0	1.300			
1	0	1	0	1	1.325			
1	0	1	0	0	1.350			
1	0	0	1	1	1.375			
1	0	0	1	0	1.400			
1	0	0	0	1	1.425			
1	0	0	0	0	1.450			
0	1	1	1	1	1.475			
0	1	1	1	0	1.500			
0	1	1	0	1	1.525			
0	1	1	0	0	1.550			
0	1	0	1	1	1.575			
0	1	0	1	0	1.600			
0	1	0	0	1	1.625			
0	1	0	0	0	1.650			
0	0	1	1	1	1.675			
0	0	1	1	0	1.700			
0	0	1	0	1	1.725			
0	0	1	0	0	1.750			
0	0	0	1	1	1.775			
0	0	0	1	0	1.800			
0	0	0	0	1	1.825			
0	0	0	0	0	1.850			

2.6.1 Mixing Processors of Different Voltages

Mixing processors operating with different VID settings (voltages) is not supported and will not be validated by Intel.



2.7 Reserved Or Unused Pins

All Reserved pins must remain unconnected on the system baseboard. Connection of these pins to $V_{\rm CC}$, $V_{\rm SS}$, or to any other signal (including one another) can result in component malfunction or incompatibility with future processors. See Chapter 5.0 for a pin listing of the processor and for the location of all Reserved pins.

For reliable operation, unused inputs or bidirectional signals should always be connected to an appropriate signal level. In a system-level design, on-die termination has been included on the processor to allow signal termination to be accomplished by the processor silicon. Most unused AGTL+ inputs should be left as no connects, as AGTL+ termination is provided on the processor silicon. However, see Table 4 for details on AGTL+ signals that do not include on-die termination. Unused active high inputs should be connected through a resistor to ground (V_{SS}). Unused outputs can be left unconnected, however this may interfere with some TAP functions, complicate debug probing, and prevent boundary scan testing. A resistor must be used when tying bidirectional signals to power or ground. When tying any signal to power or ground, a resistor will also allow for system testability. For unused AGTL+ input or I/O signals, use pull-up resistors of the same value for the on-die termination resistors (R_{TT}). See Table 12.

TAP, Asynchronous GTL+ inputs, and Asynchronous GTL+ outputs do not include on-die termination. Inputs and all used outputs must be terminated on the baseboard. Unused outputs may be terminated on the baseboard or left unconnected. Note that leaving unused outputs unterminated may interfere with some TAP functions, complicate debug probing, and prevent boundary scan testing. Signal termination for these signal types is discussed in the *ITP700 Debug Port Design Guide*.

All TESTHI[6:0] pins should be individually connected to V_{CC} via a pull-up resistor which matches the trace impedance within $\pm 10~\Omega$ TESTHI[3:0] and TESTHI[6:5] may all be tied together and pulled up to V_{CC} with a single resistor if desired. However, utilization of boundary scan test will not be functional if these pins are connected together. TESTHI4 must always be pulled up independently from the other TESTHI pins. For optimum noise margin, all pull-up resistor values used for TESTHI[6:0] pins should have a resistance value within 20 percent of the impedance of the baseboard transmission line traces. For example, if the trace impedance is $50~\Omega$, then a pull-up resistor value between 40 and $60~\Omega$ should be used. The TESTHI[6:0] termination recommendations provided in the Intel® Xeon TM Processor Datasheet are also suitable for the Intel $^{}$ ® Xeon TM processor with 533 MHz Front Side Bus. However, Intel recommends new designs or designs undergoing design updates follow the trace impedance matching termination guidelines outlined in this section.

2.8 Front Side Bus Signal Groups

In order to simplify the following discussion, the front side bus signals have been combined into groups by buffer type. AGTL+ input signals have differential input buffers, which use GTLREF as a reference level. In this document, the term "AGTL+ Input" refers to the AGTL+ input group as well as the AGTL+ I/O group when receiving. Similarly, "AGTL+ Output" refers to the AGTL+ output group as well as the AGTL+ I/O group when driving.

With the implementation of a source synchronous data bus comes the need to specify two sets of timing parameters. One set is for common clock signals whose timings are specified with respect to rising edge of BCLK0 (ADS#, HIT#, HITM#, etc.) and the second set is for the source synchronous signals which are relative to their respective strobe lines (data and address) as well as



rising edge of BCLK0. Asynchronous signals are still present (A20M#, IGNNE#, etc.) and can become active at any time during the clock cycle. Table 4 identifies which signals are common clock, source synchronous and asynchronous.

Table 4. Front Side Bus Signal Groups

Signal Group	Туре	Sig	ınals ¹	
AGTL+ Common Clock Input	Synchronous to BCLK[1:0]	BPRI#, BR[3:1]# ^{3,4} , D RS[2:0]#, RSP#, TRD	DEFER#, RESET# ⁴ , DY#	
AGTL+ Common Clock I/O	Synchronous to BCLK[1:0]	ADS#, AP[1:0]#, BINIT# ⁷ , BNR# ⁷ , BPM[5:0]# ² , BR0# ² , DBSY#, DP[3:0]#, DRDY#, HIT# ⁷ , HITM# ⁷ , LOCK#, MCERI		
		Signals	Associated Strobe	
		REQ[4:0]#,A[16:3]# ⁶	ADSTB0#	
AGTL+ Source Synchronous	Synchronous to assoc. strobe	A[35:17]# ⁵	ADSTB1#	
1/0		D[15:0]#, DBI0#	DSTBP0#, DSTBN0#	
		D[31:16]#, DBI1#	DSTBP1#, DSTBN1#	
		D[47:32]#, DBI2#	DSTBP2#, DSTBN2#	
		D[63:48]#, DBI3#	DSTBP3#, DSTBN3#	
AGTL+ Strobes	Synchronous to BCLK[1:0]	ADSTB[1:0]#, DSTBP[3:0]#, DSTBN[3:0]#		
Asynchronous GTL+ Input ⁴	Asynchronous	A20M# ⁵ , IGNNE# ⁵ , INIT# ⁶ , LINT0/INTR ⁵ , LINT1/NMI ⁵ , SLP#, STPCLK#		
Asynchronous GTL+ Output ⁴	Asynchronous	FERR#, IERR#, THE	RMTRIP#, PROCHOT#	
Front Side Bus Clock	Clock	BCLK1, BCLK0		
TAP Input ²	Synchronous to TCK	TCK, TDI, TMS, TRS	T#	
TAP Output ²	Synchronous to TCK	TDO		
Power/Other	Power/Other	BSEL[1:0], COMP[1:0], GTLREF, ODTEN, Reserved, SKTOCC#, TESTHI[6:0],VID[4:0] V _{CC} , VID_V _{CC} ⁸ , V _{CCA} , V _{CCIOPLL} , V _{SSA} , V _{SS} V _{CCSENSE} , V _{SSSENSE} , PWRGOOD		

- NOTES:
 1. Refer to Section 5.2 for signal descriptions.
- 2. These signal groups are not terminated by the processor. Refer the ITP700 Debug Port Design Guide and corresponding Design Guide for termination requirements and further details.
- 3. The Intel[®] Xeon™ processor with 533MHz Front Side Bus utilizes only BR0# and BR1#. BR2# and BR3# are not driven by the processor but must be terminated to V_{cc} . For additional details regarding the BR[3:0]# signals, see Section 5.2 and Section 7.1 and the appropriate Platform Design Guidelines.
- 4. These signals do not have on-die termination. Refer to corresponding Platform Design Guidelines for termination requirements.
- 5. Note that Reset initialization function of these pins is now a software function on the Intel[®] Xeon™ processor with 533MHz Front Side Bus.
- 6. The value of these pins during the active-to-inactive edge of RESET# to determine processor configuration options. See Section 7.1 for details.
- 7. These signals may be driven simultaneously by multiple agents (wired-or).
- 8. VID Vcc is required for correct VID logic operation of the Intel® Xeon™ processor with 533 MHz Front Side Bus. Refer to Figure 17 for details.



2.9 Asynchronous GTL+ Signals

The Intel® Xeon™ Processor with 533 MHz Front Side Bus does not utilize CMOS voltage levels on any signals that connect to the processor silicon. As a result, legacy input signals such as A20M#, IGNNE#, INIT#, LINT0/INTR, LINT1/NMI, SLP#, and STPCLK# utilize GTL+ input buffers. Legacy output FERR#/PBE# and other non-AGTL+ signals IERR#, THERMTRIP# and PROCHOT# utilize GTL+ output buffers. All of these asynchronous GTL+ signals follow the same DC requirements as AGTL+ signals, however the outputs are not driven high (during the logical 0-to-1 transition) by the processor (the major difference between GTL+ and AGTL+). Asynchronous GTL+ signals do not have setup or hold time specifications in relation to BCLK[1:0]. However, all of the asynchronous GTL+ signals are required to be asserted for at least two BCLKs in order for the processor to recognize them. See Table 10 for the DC specifications for the asynchronous GTL+ signal groups.

2.10 Maximum Ratings

Table 5 lists the processor's maximum environmental stress ratings. Functional operation at the absolute maximum and minimum is neither implied nor guaranteed. The processor should not receive a clock while subjected to these conditions. Functional operating parameters are listed in the AC and DC tables. Extended exposure to the maximum ratings may affect device reliability. Furthermore, although the processor contains protective circuitry to resist damage from static electric discharge, one should always take precautions to avoid high static voltages or electric fields.

Table 5. Processor Absolute Maximum Ratings

Symbol	Parameter	Min	Max	Unit	Notes
T _{STORAGE}	Processor storage temperature	-40	85	°C	2
V _{CC}	Any processor supply voltage with respect to Vss	-0.3	1.75	V	1
V _{inAGTL+}	AGTL+ buffer DC input voltage with respect to Vss	-0.1	1.75	V	
V _{inGTL+}	Async GTL+ buffer DC input voltage with respect to Vss	-0.1	1.75	V	
I _{VID}	Max VID pin current		5	mA	

^{1.} This rating applies to any pin of the processor.

2.11 Processor DC Specifications

The processor DC specifications in this section are defined at the processor core (pads) unless noted otherwise. See Section 5.1 for the processor pin listings and Section 5.2 for the signal definitions. The voltage and current specifications for all versions of the processor are detailed in Table 6. For platform planning refer to Figure 3. Notice that the graphs include Thermal Design Power (TDP) associated with the maximum current levels. The DC specifications for the AGTL+ signals are listed in Table 8.

^{2.} Contact Intel for storage requirements in excess of one year.



Table 6 through Table 11 list the processor DC specifications and are valid only while meeting specifications for case temperature (T_{CASE} as specified in Chapter 6.0), clock frequency, and input voltages. Care should be taken to read all notes associated with each parameter.



Table 6. Voltage and Current Specifications

Symbol	Parameter	Core Freq	Processor Signature	Min	Тур	Max	VID	Unit	Notes ¹
	V _{CC} for Intel Xeon processor with 533 MHz Front Side Bus	2 GHz 2.40 GHz 2.66 GHz 2.80 GHz 3.06 GHz	0F27h or 0F29h	1.353 1.344 1.334 1.331 1.352	Refer to Figure 3	1.461 1.456 1.452 1.450 1.467	1.5 1.5 1.5 1.5 1.525	V V V V	2, 3, 4, 5,11, 12 2, 3, 4, 5,11, 12 2, 3, 4, 5,11, 12 2, 3, 4, 5,11, 12 2, 3, 4, 5,11, 12
V _{CC}		2.40 GHz 2.66 GHz 2.80 GHz	0F25h	1.338		1.451	1.5	V	2, 3, 4, 5,11, 12
	VCC for Intel Xeon processor with 1-MB L3 cache	3.06 GHz 3.20 GHz	0F25h	1.348 1.340	Refer to Figure 3	1.468 1.463	1.525 1.525	V	2, 3, 4, 5,11, 12 2, 3, 4, 5,11, 12
	V _{CC} for Intel Xeon processor with 2-MB L3 cache	3.20 GHz	0F25h	1.340	Refer to Figure 3	1.463	1.525	V	2, 3, 4, 5,11, 12
SM_V _{CC}	SMBus supply voltage	All freq.		3.135	3.30	3.465		٧	8
	I _{CC} for Intel Xeon processor with 533 MHz Front Side Bus	2 GHz 2.40 GHz 2.66 GHz 2.80 GHz 3.06 GHz	0F27h or 0F29h			45.4 51.4 57.1 59.1 69.1		A A A A	4, 5 4, 5 4, 5 4, 5 4, 5
I _{CC}		2.40 GHz 2.66 GHz 2.80 GHz	0F25h			59.1		Α	4, 5
	ICC for Intel Xeon processor with 1-MB L3 cache	3.06 GHz 3.20 GHz	0F25h			69.1 75.0		А	4, 5 4, 5
	I _{CC} for Intel Xeon processor with 2-MB L3 cache	3.20 GHz	0F25h			75.0		Α	4, 5
I _{CC_PLL}	I _{CC} for PLL power pins	All freq				60		mA	9
I _{CC_GTLREF}	I _{CC} for GTLREF pins	All freq				15		μΑ	10
I _{SGnt} /I _{SLP}	I _{CC} Stop-Grant/Sleep	All freq				32		Α	6
I _{TCC}	I _{CC} TCC active	All freq				I _{CC}		Α	7

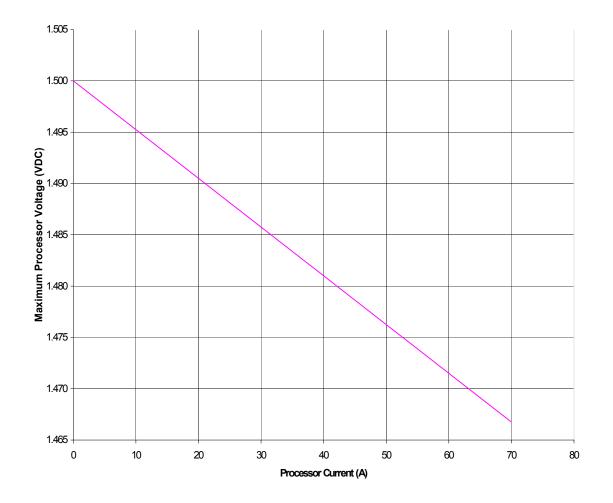
- Unless otherwise noted, all specifications in this table apply to all processors.
 These voltages are targets only. A variable voltage source should exist on systems in the event that a different voltage is required. See Section 2.6 and Table 3 for more information.
- 3. The voltage specification requirements are measured across vias on the platform for the V_{CC_SENSE} and V_{SS_SENSE} pins close to the socket with a 100 MHz bandwidth oscilloscope, 1.5 pF maximum probe capacitance, and 1 milliohm minimum impedance. The maximum length of ground wire on the probe should be less than 5 mm. Ensure external noise from the system is not coupled in the scope probe.



- 4. The processor should not be subjected to any static Vcc level that exceeds the voltage vs current load-line for any given current loading (as shown in figure 3 for VID=1.500V and figure 4 for VID=1.525V). Moreover, Vcc should never exceed Vcc_VID. Failure to adhere to this specification can shorten the processor lifetime.
 5. Vcc_max and Vcc_min are defined at a load of Icc_max. Icc_max is defined at Vcc_max.
- 6. The current specified is also for AutoHALT State.
- 7. The maximum instantaneous current that the processor will draw while the thermal control circuit is active as indicated by the assertion of PROCHOT# is the same as the maximum I CC for the processor. Average Icc does drop when PROCHOT# is active, as long as the Thermal Monitor is active

 8. VID_V_{CC} is required for correct operation of the processor VID logic. Refer to Figure 17 for details.
- 9. This specification applies to the PLL power pins VCCA and VCCIOPLL. See Section 2.5 for details. This parameter is based on design characterization and is not tested 10. This specification applies to each GTLREF pin.
- 11. The loadlines specify voltage limits at the die measured at V_{CC_SENSE} and V_{SS_SENSE} pins. Voltage regulation feedback for voltage regulator circuits must be taken from processor V_{CC} and V_{SS} pins.
- 12. Adherence to this loadline specification is required to ensure reliable processor operation.

Figure 3. Intel® Xeon™ processor with 533 MHz Front Side Bus Voltage-Current **Projections (VID 1.5V)**





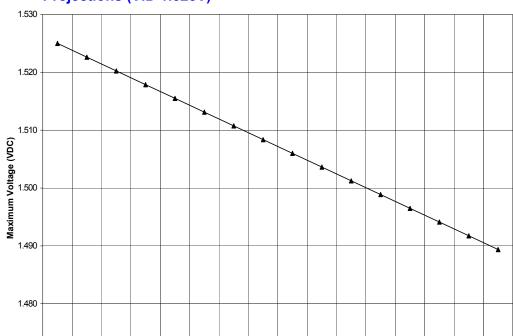


Figure 4. Intel Xeon processor with 533 MHz Front Side Bus Voltage-Current Projections (VID 1.525V)

Table 7. Front Side Bus Differential BCLK Specifications

Processor Current (A)

Symbol	Parameter	Min	Тур	Max	Unit	Figure	Notes 1
V _L	Input Low Voltage	150	0.000	N/A	V	7	
V _H	Input High Voltage	0.660	0.710	0.850	V	7	
V _{CROSS(abs)}	Absolute Crossing Point	0.250	N/A	0.550	٧	7, 7	2,8
V _{CROSS(rel)}	Relative Crossing Point	0.250 + 0.5(V _{Havg} - 0.710)	N/A	0.550 + 0.5(V _{Havg} - 0.710)	٧	7, 7	2,3,8,9
$\Delta V_{ ext{CROSS}}$	Range of Crossing Points	N/A	N/A	0.140	٧	7, 7	2,10
V _{OV}	Overshoot	N/A	N/A	V _H + 0.3	V	7	4
V _{US}	Undershoot	-0.300	N/A	N/A	V	7	5
V _{RBM}	Ringback Margin	0.200	N/A	N/A	V	6	
V _{TM}	Threshold Margin	V _{cross} - 0.100	N/A	V _{cross} + 0.100	V	6	

NOTES:.

1.470



- 1. Unless otherwise noted, all specifications in this table apply to all processor frequencies.
- 2. Crossing voltage is defined as the instantaneous voltage value when the rising edge of BCLK0 equals the falling edge of BCLK1.
- V_{Havg} is the statistical average of the V_H measured by the oscilloscope.
 Overshoot is defined as the absolute value of the maximum voltage.
- 5. Undershoot is defined as the absolute value of the minimum voltage.
- 6. Ringback Margin is defined as the absolute voltage difference between the maximum Rising Edge Ringback and the maximum Falling Edge Ringback.
- 7. Threshold Region is defined as a region entered around the crossing point voltage in which the differential receiver switches. It includes input threshold hysteresis.
- 8. The crossing point must meet the absolute and relative crossing point specifications simultaneously.
- 9. V_{Havg} can be measured directly using "Vtop" on Agilent* scopes and "High" on Tektronix* scopes. $10.\Delta V_{\text{CROSS}}$ is defined as the total variation of all crossing voltages as defined in note 2.

Table 8. AGTL+ Signal Group DC Specifications

Symbol	Parameter	Min	Max	Unit	Notes 1,7
V _{IH}	Input High Voltage	1.10 * GTLREF	V _{CC}	V	2, 4, 6
V _{IL}	Input Low Voltage	0.0	0.90 * GTLREF	V	3, 6
V _{OH}	Output High Voltage	N/A	V _{CC}	V	4, 6
I _{OL}	Output Low Current	N/A	Vcc / (0.50 * R _{TT_min} + R _{ON_min}) = 50	mA	6
I _{HI}	Pin Leakage High	N/A	100	μA	9
I _{LO}	Pin Leakage Low	N/A	500	μA	8
R _{ON}	Buffer On Resistance	7	11	Ω	5, 7

- 1. Unless otherwise noted, all specifications in this table apply to all processor frequencies and cache sizes.
- 2. V_{IH} is defined as the minimum voltage level at a receiving agent that will be interpreted as a logical high
- 3. V_{IL} is defined as the maximum voltage level at a receiving agent that will be interpreted as a logical low value.
- 4. V_{IH} and V_{ON} may experience excursions above V_{CC}. However, input signal drivers must comply with the signal quality specifications in Chapter 3.0.
- 5. Refer to the Intel®Xeon™ Processor with 533 MHz Front Side Bus Signal Integrity Models for I/V characteristics.
- 6. The V_{CC} referred to in these specifications refers to instantaneous V_{CC} .

 7. $V_{OL\ MAX}$ of 0.450 V is guaranteed when driving into a test load as indicated in Figure 5, with R_{TT} enabled.
- 8. Leakage to V_{CC} with pin held at 300 mV.
 9. Leakage to V_{SS} with pin held at V_{CC}.

Table 9. TAP and PWRGOOD Signal Group DC Specifications

Symbol	Parameter	Min	Max	Unit	Notes 1, 2
V _{HYS}	TAP Input Hysteresis	200	300		8
V _{T+}	TAP input low to high threshold voltage	0.5 * (V _{CC} + V _{HYS_MIN})	0.5 * (V _{CC} + V _{HYS_MAX})		5
V _{T-}	TAP input high to low threshold voltage	0.5 * (V _{CC} - V _{HYS_MAX})	0.5 * (V _{CC} - V _{HYS_MIN})		5
V _{OH}	Output High Voltage	N/A	V _{CC}	V	3, 5
I _{OL}	Output Low Current		40	mA	6, 7
I _{HI}	Pin Leakage High	N/A	100	μΑ	10
I _{LO}	Pin Leakage Low	N/A	500	μΑ	9



R _{ON}	Buffer On Resistance	8.75	13.75	Ω	4
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NOTES:.

- 1. Unless otherwise noted, all specifications in this table apply to all processor frequencies and cache sizes.
- 2. All outputs are open drain
- 3. TAP signal group must meet the system signal quality specification in Chapter 3.0.
- 4. Refer to the Intel® Xeon™ Processor with 533 MHz Front Side Bus Signal Integrity Models for I/V characteristics.
- 5. The V_{CC} referred to in these specifications refers to instantaneous V_{CC}.
 6. The maximum output current is based on maximum current handling capability of the buffer and is not specified into the test load.
- 7. $V_{OL\ MAX}$ of 0.300V is guaranteed when driving a test load.
- 8. V_{HYS} represents the amount of hysteresis, nominally centered about 0.5*V_{CC}, for all TAP inputs.
- 9. Leakage to V_{CC} with Pin held at 300 mV.
- 10.Leakage to V_{SS} with pin held at V_{CC}.

Table 10. Asynchronous GTL+ Signal Group DC Specifications

Symbol	Parameter	Min	Max	Unit	Notes ^{1, 7}
V _{IH}	Input High Voltage	1.10 * GTLREF	V _{CC}	V	3, 5, 7
V_{IL}	Input Low Voltage	0.0	0.90 * GTLREF	V	4, 6
V_{OH}	Output High Voltage	N/A	Vcc	V	2, 5, 7
I_{OL}	Output Low Current		50	mA	8,9
I _{HI}	Pin Leakage High	N/A	100	μΑ	11
I _{LO}	Pin Leakage Low	N/A	500	μA	10
R _{ON}	Buffer On Resistance	7	11	Ω	6

NOTES:

- 1. Unless otherwise noted, all specifications in this table apply to all processor frequencies and cache sizes.
- 2. All outputs are open drain
- 3. VIH is defined as the minimum voltage level at a receiving agent that will be interpreted as a logical high
- 4. V_{II} is defined as the maximum voltage level at a receiving agent that will be interpreted as a logical low value.
- 5. VIH and VOH may experience excursions above VCC. However, input signal drivers must comply with the signal quality specifications in Chapter 3.0.
- 6. Refer to the Intel®Xeon™Processor with 533 MHz Front Side Bus Signal Integrity Models for I/V characteristics.
- 7. The V_{CC} referred to in these specifications refers to instantaneous V_{CC} .
- 8. The maximum output current is based on maximum current handling capability of the buffer and is not specified into the test load.
- 9. V_{OL_MAX} of 0.450 V is guaranteed when driving into a test load as indicated in Figure 5, with R_{TT} enabled.
- 10. Leakage to V_{CC} with Pin held at 300 mV.
- 11. Leakage to V_{SS} with pin held at V_{CC}.

NOTES:

- 1. Unless otherwise noted, all specifications in this table apply to all processor frequencies and cache sizes.
- 2. These parameters are based on design characterization and are not tested.

Table 11. BSEL[1:0] and VID[4:0] DC Specifications

Symbol	Parameter	Min	Max	Unit	Notes ¹
Ron (BSEL)	Buffer On Resistance	9.2	14.3	Ω	2
Ron (VID)	Buffer On Resistance	7.8	12.8	Ω	2
I _{HI}	Pin Leakage Hi	N/A	100	μΑ	3



- 1. Unless otherwise noted, all specifications in this table apply to all processor frequencies.
- 2. These parameters are not tested and are based on design simulations.
- 3. Leakage to Vss with pin held at 2.50V.

2.12 AGTL+ Front Side Bus Specifications

Routing topologies are dependent on the number of processors supported and the chipset used in the design. Please refer to the appropriate platform design guidelines. In most cases, termination resistors are not required as these are integrated into the processor. See Table 4 for details on which AGTL+ signals do not include on-die termination. The termination resistors are enabled or disabled through the ODTEN pin. To enable termination, this pin should be pulled up to V_{CC} through a resistor and to disable termination, this pin should be pulled down to V_{SS} through a resistor. For optimum noise margin, all pull-up and pull-down resistor values used for the ODTEN pin should have a resistance value within 20 percent of the impedance of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω , then a value between 40 and 60 Ω should be used. The processor's on-die termination must be enabled for the end agent only. Please refer to Table 12 for termination resistor values. For more details on platform design see the appropriate platform design guidelines.

Valid high and low levels are determined by the input buffers via comparing with a reference voltage called GTLREF.

Table 12 lists the GTLREF specifications. The AGTL+ reference voltage (GTLREF) should be generated on the baseboard using high precision voltage divider circuits. It is important that the baseboard impedance is held to the specified tolerance, and that the intrinsic trace capacitance for the AGTL+ signal group traces is known and well-controlled. For more details on platform design see the appropriate platform design guidelines.

Table 12. AGTL+ Bu	is Voltage Definitions
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Symbol	Parameter	Min	Тур	Max	Units	Notes ¹
GTLREF	Bus Reference Voltage	2/3 * V _{CC} - 2%	2/3 * V _{CC}	2/3 * V _{CC} + 2%	V	2, 3, 6
GTLREF New Design	Bus Reference Voltage	0.63*Vcc - 2%	0.63*Vcc	0.63*Vcc + 2%	V	2, 3, 6,
R _{TT}	Termination Resistance	36	41	46	Ω	4
R _{TT} New Design	Termination Resistance	45	50	55	Ω	4, 9
COMP[1:0]	COMP Resistance	42.77	43.2	43.63	Ω	5, 8
COMP[1:0] New Design	COMP Resistance	49.55	50	50.45	Ω	5, 8, 9

NOTES:

- 1. Unless otherwise noted, all specifications in this table apply to all processor frequencies.
- The tolerances for this specification have been stated generically to enable system designer to calculate the minimum values across the range of V_{CC}.
- GTLREF is generated from V_{CC} on the baseboard by a voltage divider of 1 percent resistors. Refer to the appropriate platform design guidelines for implementation details.
- 4. R_{TT} is the on-die termination resistance measured from V_{CC} to 1/3 V_{CC} at the AGTL+ output driver. Refer to the Intel[®] Xeon™ Processor with 533MHz Front Side Bus Signal Integrity Models for I/V characteristics.
- COMP resistors are pull downs to V_{SS} provided on the baseboard with 1% tolerance. See the appropriate platform design guidelines for implementation details.
- 6. The V_{CC} referred to in these specifications refers to instantaneous V_{CC}.
- 7. The COMP resistance value varies by platform. Refer to the appropriate platform design guideline for the recommended COMP resistance value.



- 8. The values for R_{TT} and COMP noted as 'New Designs' apply to designs that are optimized for the Intel[®] Xeon™ processor with 533MHz Front Side Bus. Refer to the appropriate platform design guideline for the recommended COMP resistance value.
- 9. This specification applies to the Intel® Xeon™processor with 533MHz Front Side Bus when implemented in platforms that do not include forward compatibility with future processors.

Table 13. Miscellaneous Signals + Specifications

T# Parameter	Min	Max	Unit	Figure	Notes
T39: THERMTRIP# to Vcc Removal		0.5	S	6	

Figure 5. Electrical Test Circuit

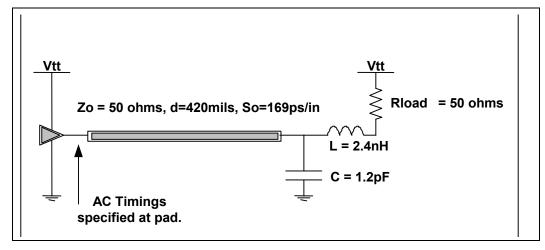
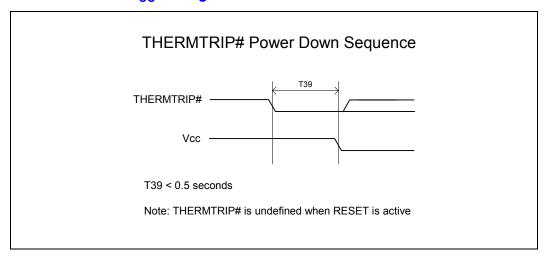


Figure 6. THERMTRIP# to V_{CC} Timing





3.0 Mechanical Specifications

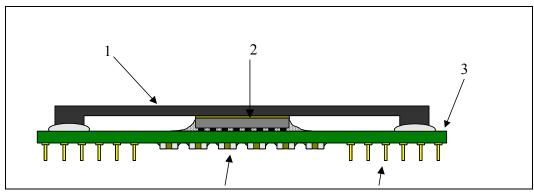
The Intel® Xeon™ Processor with 533 MHz Front Side Bus uses the Flip Chip Micro-Pin Grid Array (FC-mPGA) package containing the processor die covered by an integrated heat spreader (IHS) Mechanical specifications for the processor are given in this section. See Section 1.1 for terminology definitions. Figure 7 provides a basic assembly drawing and includes the components which make up the entire processor. Package dimensions are provided in Table 14.

The Intel® XeonTM processor with 533 MHz Front Side Bus utilizes a surface mount 604-pin zero-insertion force (ZIF) socket for installation into the baseboard. See the *604-Pin Socket Design Guidelines* for further details on the processor socket.

For Figure 9 through Figure 13, the following notes apply:

- 1. Unless otherwise specified, the following drawings are dimensioned in millimeters.
- 2. All dimensions are not tested, but are guaranteed by design characterization.
- 3. Figures and drawings labelled as "Reference Dimensions" are provided for informational purposes only. Reference Dimensions are extracted from the mechanical design database and are nominal dimensions with no tolerance information applied. Reference Dimensions are NOT checked as part of the processor manufacturing process. Unless noted as such, dimensions in parentheses without tolerances are Reference Dimensions.
- 4. Drawings are not to scale.

Figure 7. FC-mPGA2 Processor Package Assembly Drawing



Note: applies to Intel Xeon processor in the FC-mPGA2 package.

- 1. Integrated Heat Spreader (IHS)
- 2. Processor die
- 3. FC-mPGA2 package
- 4. Land side Capacitors
- 5. Package Pin



3.1 Mechanical Specifications

Figure 8. FC-mPGA Processor Package Top View: Component Placement Detail

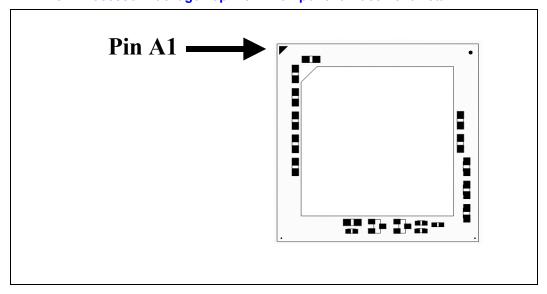




Figure 9. Intel® Xeon™ Processor with 533 MHz Front Side Bus in the FC-mPGA2 Package Drawing

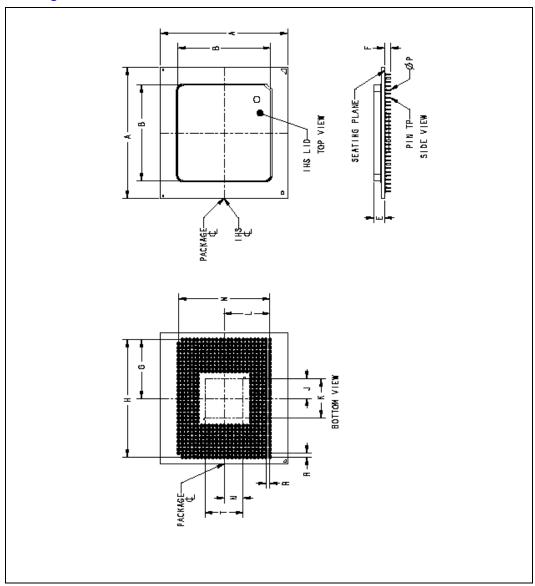




Table 14. Dimensions for the Intel® Xeon™ Processor with 533 MHz Front Side Bus in the FC-mPGA2 Package

Symbol		Milimeters		Notes
	Min	Nominal	Max	
Α	42.40	42.50	42.60	
В	30.90	31.00	31.10	
Е	3.42	3.60	3.78	
F	1.95	2.03	2.11	
G	18.80	19.05	19.30	
Н	37.85	38.10	38.35	
J		6.35		Nominal Component Keepin
K		12.70		Nominal Component Keepin
L	14.99	15.24	15.49	
М	30.23	30.48	30.73	
N		6.35		Nominal Component Keepin
R		1.27		Nominal
Τ		12.70		
φР	0.26	0.31	0.36	Pin Diameter
Pin Tp			0.25	

Figure 10 details the keep-in zone for components mounted to the top side of the processor interposer. The components include the EEPROM, thermal sensor, resistors and capacitors.

Figure 10. FC-mPGA2 Processor Package Top View: Component Height Keep-in

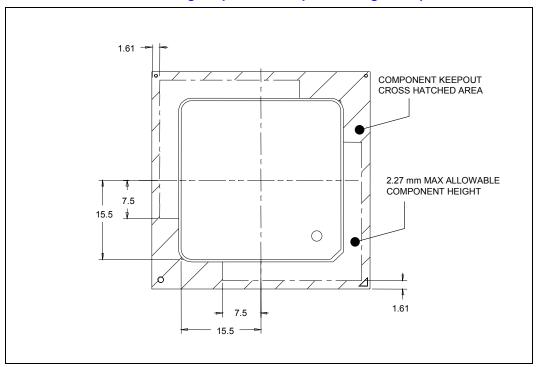




Figure 11 details the keep-in specification for pin-side components. The processor may contain pin side capacitors mounted to the processor package. These capacitors will be exposed within the opening of the interposer cavity.

Figure 11. FC-mPGA2 Processor Package Cross Section View: Pin Side Component Keep-in

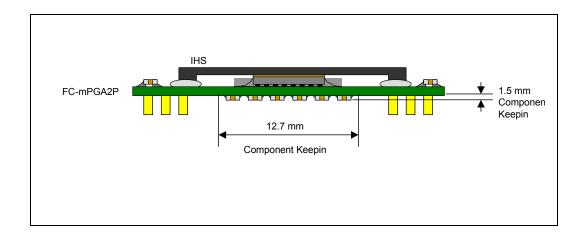
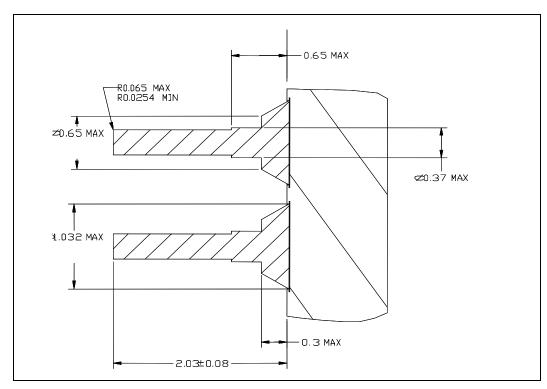




Figure 12. FC-mPGA2 Processor Package: Pin Detail

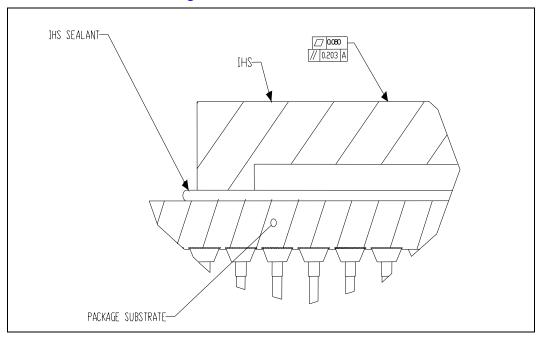


- Kovar pin with plating of 0.2 micrometers Au over 2.0 micrometer Ni.
 0.254 Diametric true position, pin to pin.



Figure 13 details the flatness and tilt specifications for the IHS of the Intel Xeon processor with 533 MHz Front Side Bus, respectively. Tilt is measured with the reference datum set to the bottom of the processor interposer.

Figure 13. IHS Flatness and Tilt Drawing



3.2 Processor Package Load Specifications

Table 15 provides dynamic and static load specifications for the processor IHS. These mechanical load limits should not be exceeded during heat sink assembly, mechanical stress testing, or standard drop and shipping conditions. The heat sink attach solutions must not induce continuous stress onto the processor with the exception of a uniform load to maintain the heat sink-to-processor thermal interface. It is not recommended to use any portion of the processor interposer as a mechanical reference or load bearing surface for thermal solutions.

Table 15. Package Dynamic and Static Load Specifications

Parameter	Max	Unit	Unit
Static	50	lbf	1, 2, 3
Dynamic	50 + 1 lb * 50G input * 1.8 (AF) = 140	lbf	1, 2, 4, 5

NOTES:

- 1. This specification applies to a uniform compressed load.
- 2. This is the maximum static force that can be applied by the heatsink and clip to maintain the heatsink and processor interface.
- 3. These parameters are based on design characterization and not tested.
- 4. Dynamic loading specifications are defined assuming a maximum duration of 11ms.
- 5. The heatsink weight is assumed to be one pound. Shock input to the system during shock testing is assumed to be 50 G's. AF is the amplification factor.



3.3 Insertion Specifications

The processor can be inserted and removed 15 times from a 604-pin socket meeting the *mPGA604* Socket Design Guidelines document. Note that this specification is based on design characterization and is not tested.

3.4 Mass Specifications

Table 16 specifies the processors mass. This includes all components which make up the entire processor product.

Table 16. Processor Mass

Processor	Mass (grams)
Intel® Xeon™ Processor with 533 MHz Front Side Bus	25

3.5 Materials

The processor is assembled from several components. The basic material properties are described in Table 17.

Table 17. Processor Material Properties

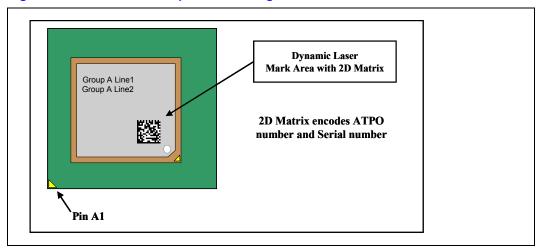
Component	Material
Integrated Heat Spreader	Nickel plated copper
FC-BGA	BT Resin
Interposer	FR4
Interposer pins	Kovar with Gold over nickel



3.6 Markings

The following section details the processor top-side laser markings. It is provided to aid in the identification of the processor.

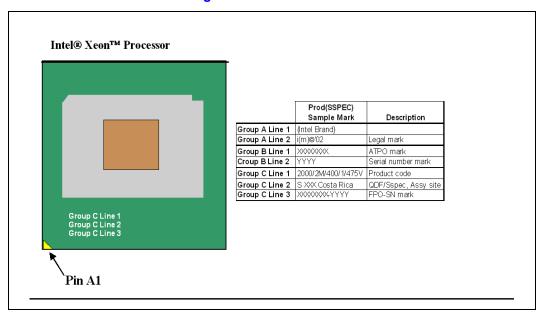
Figure 14. Processor Top-Side Markings



NOTE:

- 1. Character size for laser markings is: height 0.050" (1.27mm), width 0.032" (0.81mm).
- 2. All characters will be in upper case.

Figure 15. Processor Bottom-Side Markings





3.7 Pin-Out Diagram

This section provides two view of the processor pin grid. Figure 16 and Figure 17 detail the coordinates of the processor pins.

Figure 16. Processor Pin Out Diagram: Top View

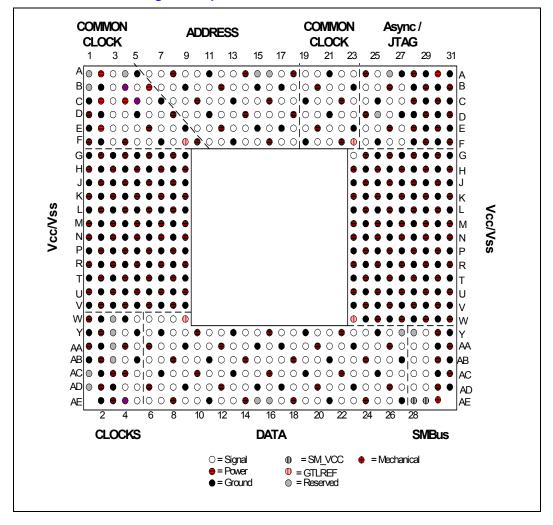
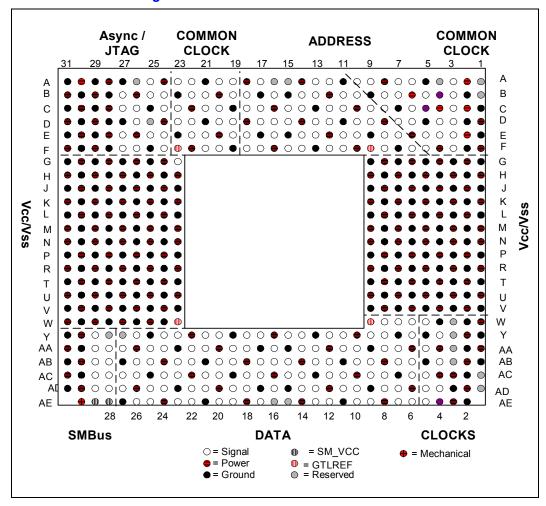




Figure 17. Processor Pin Out Diagram: Bottom View







4.0 Pin Listing and Signal Definitions

4.1 Processor Pin Assignments

Section 2.8 contains the front side bus signal groups in Table 4 for the Intel[®] XeonTM Processor with 533 MHz Front Side Bus. This section provides a sorted pin list in Table 38 and Table 39. Table 38 is a listing of all processor pins ordered alphabetically by pin name. Table 39 is a listing of all processor pins ordered by pin number.

4.1.1 Pin Listing by Pin Name

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
A3#	A22	Source Sync	Input/Output
A4#	A20	Source Sync	Input/Output
A5#	B18	Source Sync	Input/Output
A6#	C18	Source Sync	Input/Output
A7#	A19	Source Sync	Input/Output
A8#	C17	Source Sync	Input/Output
A9#	D17	Source Sync	Input/Output
A10#	A13	Source Sync	Input/Output
A11#	B16	Source Sync	Input/Output
A12#	B14	Source Sync	Input/Output
A13#	B13	Source Sync	Input/Output
A14#	A12	Source Sync	Input/Output
A15#	C15	Source Sync	Input/Output
A16#	C14	Source Sync	Input/Output
A17#	D16	Source Sync	Input/Output
A18#	D15	Source Sync	Input/Output
A19#	F15	Source Sync	Input/Output
A20#	A10	Source Sync	Input/Output
A21#	B10	Source Sync	Input/Output
A22#	B11	Source Sync	Input/Output
A23#	C12	Source Sync	Input/Output
A24#	E14	Source Sync	Input/Output
A25#	D13	Source Sync	Input/Output
A26#	A9	Source Sync	Input/Output
A27#	B8	Source Sync	Input/Output

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
A28#	E13	Source Sync	Input/Output
A29#	D12	Source Sync	Input/Output
A30#	C11	Source Sync	Input/Output
A31#	В7	Source Sync	Input/Output
A32#	A6	Source Sync	Input/Output
A33#	A7	Source Sync	Input/Output
A34#	C9	Source Sync	Input/Output
A35#	C8	Source Sync	Input/Output
A20M#	F27	Async GTL+	Input
ADS#	D19	Common Clk	Input/Output
ADSTB0#	F17	Source Sync	Input/Output
ADSTB1#	F14	Source Sync	Input/Output
AP0#	E10	Common Clk	Input/Output
AP1#	D9	Common Clk	Input/Output
BCLK0	Y4	Sys Bus Clk	Input
BCLK1	W5	Sys Bus Clk	Input
BINIT#	F11	Common Clk	Input/Output
BNR#	F20	Common Clk	Input/Output
BPM0#	F6	Common Clk	Input/Output
BPM1#	F8	Common Clk	Input/Output
BPM2#	E7	Common Clk	Input/Output
BPM3#	F5	Common Clk	Input/Output
BPM4#	E8	Common Clk	Input/Output
BPM5#	E4	Common Clk	Input/Output
BPRI#	D23	Common Clk	Input
BR0#	D20	Common Clk	Input/Output



Table 38. Pin Listing by Pin Name

Signal Pin Name Pin No. **Direction Buffer Type** BR1# F12 Common Clk Input BR2# ¹ E11 Common Clk Input BR3# ¹ D10 Common Clk Input BSEL0 AA3 Power/Other Output² Output² BSEL1 AB3 Power/Other COMP0 AD16 Power/Other Input COMP1 E16 Power/Other Input D0# Y26 Source Sync Input/Output AA27 D1# Source Sync Input/Output D2# Input/Output Y24 Source Sync D3# AA25 Source Sync Input/Output AD27 D4# Source Sync Input/Output D5# Y23 Input/Output Source Sync D6# AA24 Source Sync Input/Output D7# AB26 Input/Output Source Sync D8# AB25 Input/Output Source Sync D9# AB23 Input/Output Source Sync AA22 D10# Source Sync Input/Output D11# AA21 Source Sync Input/Output D12# AB20 Input/Output Source Sync D13# AB22 Source Sync Input/Output D14# **AB19** Input/Output Source Sync D15# **AA19** Input/Output Source Sync D16# AE26 Source Sync Input/Output AC26 D17# Input/Output Source Sync D18# AD25 Source Sync Input/Output AE25 D19# Source Sync Input/Output D20# AC24 Source Sync Input/Output D21# AD24 Source Sync Input/Output D22# AE23 Source Sync Input/Output D23# AC23 Source Sync Input/Output D24# **AA18** Input/Output Source Sync D25# AC20 Source Sync Input/Output D26# AC21 Source Sync Input/Output D27# AE22 Input/Output Source Sync D28# AE20 Source Sync Input/Output D29# AD21 Input/Output Source Sync D30# AD19 Source Sync Input/Output D31# **AB17** Source Sync Input/Output

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
D32#	AB16	Source Sync	Input/Output
D33#	AA16	Source Sync	Input/Output
D34#	AC17	Source Sync	Input/Output
D35#	AE13	Source Sync	Input/Output
D36#	AD18	Source Sync	Input/Output
D37#	AB15	Source Sync	Input/Output
D38#	AD13	Source Sync	Input/Output
D39#	AD14	Source Sync	Input/Output
D40#	AD11	Source Sync	Input/Output
D41#	AC12	Source Sync	Input/Output
D42#	AE10	Source Sync	Input/Output
D43#	AC11	Source Sync	Input/Output
D44#	AE9	Source Sync	Input/Output
D45#	AD10	Source Sync	Input/Output
D46#	AD8	Source Sync	Input/Output
D47#	AC9	Source Sync	Input/Output
D48#	AA13	Source Sync	Input/Output
D49#	AA14	Source Sync	Input/Output
D50#	AC14	Source Sync	Input/Output
D51#	AB12	Source Sync	Input/Output
D52#	AB13	Source Sync	Input/Output
D53#	AA11	Source Sync	Input/Output
D54#	AA10	Source Sync	Input/Output
D55#	AB10	Source Sync	Input/Output
D56#	AC8	Source Sync	Input/Output
D57#	AD7	Source Sync	Input/Output
D58#	AE7	Source Sync	Input/Output
D59#	AC6	Source Sync	Input/Output
D60#	AC5	Source Sync	Input/Output
D61#	AA8	Source Sync	Input/Output
D62#	Y9	Source Sync	Input/Output
D63#	AB6	Source Sync	Input/Output
DBSY#	F18	Common Clk	Input/Output
DEFER#	C23	Common Clk	Input
DBI0#	AC27	Source Sync	Input/Output
DBI1#	AD22	Source Sync	Input/Output
DBI2#	AE12	Source Sync	Input/Output
DBI3#	AB9	Source Sync	Input/Output
DP0#	AC18	Common Clk	Input/Output



Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
DP1#	AE19	Common Clk	Input/Output
DP2#	AC15	Common Clk	Input/Output
DP3#	AE17	Common Clk	Input/Output
DRDY#	E18	Common Clk	Input/Output
DSTBN0#	Y21	Source Sync	Input/Output
DSTBN1#	Y18	Source Sync	Input/Output
DSTBN2#	Y15	Source Sync	Input/Output
DSTBN3#	Y12	Source Sync	Input/Output
DSTBP0#	Y20	Source Sync	Input/Output
DSTBP1#	Y17	Source Sync	Input/Output
DSTBP2#	Y14	Source Sync	Input/Output
DSTBP3#	Y11	Source Sync	Input/Output
FERR#	E27	Async GTL+	Output
GTLREF	W23	Power/Other	Input
GTLREF	W9	Power/Other	Input
GTLREF	F23	Power/Other	Input
GTLREF	F9	Power/Other	Input
HIT#	E22	Common Clk	Input/Output
HITM#	A23	Common Clk	Input/Output
IERR#	E5	Async GTL+	Output
IGNNE#	C26	Async GTL+	Input
INIT#	D6	Async GTL+	Input
LINT0	B24	Async GTL+	Input
LINT1	G23	Async GTL+	Input
LOCK#	A17	Common Clk	Input/Output
MCERR#	D7	Common Clk	Input/Output
ODTEN	B5	Power/Other	Input
PROCHOT#	B25	Async GTL+	Output
PWRGOOD	AB7	Async GTL+	Input
REQ0#	B19	Source Sync	Input/Output
REQ1#	B21	Source Sync	Input/Output
REQ2#	C21	Source Sync	Input/Output
REQ3#	C20	Source Sync	Input/Output
REQ4#	B22	Source Sync	Input/Output
Reserved	A1	Reserved	Reserved
Reserved	A4	Reserved	Reserved
Reserved	A15	Reserved	Reserved
Reserved	A16	Reserved	Reserved
Reserved	A26	Reserved	Reserved

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
Reserved	B1	Reserved	Reserved
Reserved	C5	Reserved	Reserved
Reserved	D25	Reserved	Reserved
Reserved	W3	Reserved	Reserved
Reserved	Y3	Reserved	Reserved
THERMDA	Y27	Anode Pin	Output
THERMDC	Y28	Cathode Pin	Output
Reserved	AC1	Reserved	Reserved
Reserved	AD1	Reserved	Reserved
SMB_PRT	AE4	Ground	VSS
Reserved	AE15	Reserved	Reserved
Reserved	AE16	Reserved	Reserved
RESET#	Y8	Common Clk	Input
RS0#	E21	Common Clk	Input
RS1#	D22	Common Clk	Input
RS2#	F21	Common Clk	Input
RSP#	C6	Common Clk	Input
SKTOCC#	A3	Power/Other	Output
SLP#	AE6	Async GTL+	Input
NC	AD28	Reserved	
NC	AC28	Reserved	
NC	AC29	Reserved	
NC	AA29	Reserved	
NC	AB29	Reserved	
NC	AB28	Reserved	
NC	AA28	Reserved	
NC	Y29	Reserved	
NC	AE28	Reserved	
NC	AE29	Reserved	
NC	AD29	Reserved	
SMI#	C27	Async GTL+	Input
STPCLK#	D4	Async GTL+	Input
TCK	E24	TAP	Input
TDI	C24	TAP	Input
TDO	E25	TAP	Output
TESTHI0	W6	Power/Other	Input
TESTHI1	W7	Power/Other	Input
TESTHI2	W8	Power/Other	Input
TESTHI3	Y6	Power/Other	Input



Table 38. Pin Listing by Pin Name

Signal **Pin Name** Pin No. **Direction Buffer Type** TESTHI4 AA7 Power/Other Input TESTHI5 AD5 Power/Other Input TESTHI6 AE5 Power/Other Input THERMTRIP# F26 Async GTL+ Output TMS TAP A25 Input TRDY# E19 Common Clk Input TRST# F24 TAP Input VCC A2 Power/Other VCC Power/Other **A8** VCC A14 Power/Other VCC A18 Power/Other VCC A24 Power/Other VCC A28 Power/Other VCC A30 Power/Other VCC B4 Power/Other VCC B6 Power/Other VCC B12 Power/Other VCC B20 Power/Other VCC B26 Power/Other VCC B29 Power/Other Power/Other VCC **B31** VCC C2 Power/Other VCC C4 Power/Other VCC C10 Power/Other VCC C16 Power/Other VCC C22 Power/Other VCC C28 Power/Other VCC C30 Power/Other VCC D1 Power/Other VCC D8 Power/Other VCC D14 Power/Other VCC D18 Power/Other VCC D24 Power/Other VCC D29 Power/Other VCC D31 Power/Other VCC E2 Power/Other VCC E6 Power/Other VCC E12 Power/Other VCC E20 Power/Other

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
VCC	E26	Power/Other	
VCC	E28	Power/Other	
VCC	E30	Power/Other	
VCC	F1	Power/Other	
VCC	F4	Power/Other	
VCC	F10	Power/Other	
VCC	F16	Power/Other	
VCC	F22	Power/Other	
VCC	F29	Power/Other	
VCC	F31	Power/Other	
VCC	G2	Power/Other	
VCC	G4	Power/Other	
VCC	G6	Power/Other	
VCC	G8	Power/Other	
VCC	G24	Power/Other	
VCC	G26	Power/Other	
VCC	G28	Power/Other	
VCC	G30	Power/Other	
VCC	H1	Power/Other	
VCC	Н3	Power/Other	
VCC	H5	Power/Other	
VCC	H7	Power/Other	
VCC	H9	Power/Other	
VCC	H23	Power/Other	
VCC	H25	Power/Other	
VCC	H27	Power/Other	
VCC	H29	Power/Other	
VCC	H31	Power/Other	
VCC	J2	Power/Other	
VCC	J4	Power/Other	
VCC	J6	Power/Other	
VCC	J8	Power/Other	
VCC	J24	Power/Other	
VCC	J26	Power/Other	
VCC	J28	Power/Other	
VCC	J30	Power/Other	
VCC	K1	Power/Other	
VCC	K3	Power/Other	
VCC	K5	Power/Other	



Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
VCC	K7	Power/Other	
VCC	K9	Power/Other	
VCC	K23	Power/Other	
VCC	K25	Power/Other	
VCC	K27	Power/Other	
VCC	K29	Power/Other	
VCC	K31	Power/Other	
VCC	L2	Power/Other	
VCC	L4	Power/Other	
VCC	L6	Power/Other	
VCC	L8	Power/Other	
VCC	L24	Power/Other	
VCC	L26	Power/Other	
VCC	L28	Power/Other	
VCC	L30	Power/Other	
VCC	M1	Power/Other	
VCC	М3	Power/Other	
VCC	M5	Power/Other	
VCC	M7	Power/Other	
VCC	М9	Power/Other	
VCC	M23	Power/Other	
VCC	M25	Power/Other	
VCC	M27	Power/Other	
VCC	M29	Power/Other	
VCC	M31	Power/Other	
VCC	N1	Power/Other	
VCC	N3	Power/Other	
VCC	N5	Power/Other	
VCC	N7	Power/Other	
VCC	N9	Power/Other	
VCC	N23	Power/Other	
VCC	N25	Power/Other	
VCC	N27	Power/Other	
VCC	N29	Power/Other	
VCC	N31	Power/Other	
VCC	P2	Power/Other	
VCC	P4	Power/Other	
VCC	P6	Power/Other	
VCC	P8	Power/Other	

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
VCC	P24	Power/Other	
VCC	P26	Power/Other	
VCC	P28	Power/Other	
VCC	P30	Power/Other	
VCC	R1	Power/Other	
VCC	R3	Power/Other	
VCC	R5	Power/Other	
VCC	R7	Power/Other	
VCC	R9	Power/Other	
VCC	R23	Power/Other	
VCC	R25	Power/Other	
VCC	R27	Power/Other	
VCC	R29	Power/Other	
VCC	R31	Power/Other	
VCC	T2	Power/Other	
VCC	T4	Power/Other	
VCC	Т6	Power/Other	
VCC	Т8	Power/Other	
VCC	T24	Power/Other	
VCC	T26	Power/Other	
VCC	T28	Power/Other	
VCC	T30	Power/Other	
VCC	U1	Power/Other	
VCC	U3	Power/Other	
VCC	U5	Power/Other	
VCC	U7	Power/Other	
VCC	U9	Power/Other	
VCC	U23	Power/Other	
VCC	U25	Power/Other	
VCC	U27	Power/Other	
VCC	U29	Power/Other	
VCC	U31	Power/Other	
VCC	V2	Power/Other	
VCC	V4	Power/Other	
VCC	V6	Power/Other	
VCC	V8	Power/Other	
VCC	V24	Power/Other	
VCC	V26	Power/Other	
VCC	V28	Power/Other	



Table 38. Pin Listing by Pin Name

Signal Pin Name Pin No. **Direction Buffer Type** VCC V30 Power/Other VCC W1 Power/Other VCC W25 Power/Other VCC W27 Power/Other VCC W29 Power/Other VCC W31 Power/Other VCC Y10 Power/Other VCC Power/Other Y16 VCC Y2 Power/Other VCC Y22 Power/Other VCC Y30 Power/Other VCC AA1 Power/Other VCC AA4 Power/Other VCC AA6 Power/Other VCC AA12 Power/Other VCC AA20 Power/Other VCC AA26 Power/Other VCC AA31 Power/Other VCC AB2 Power/Other VCC AB8 Power/Other VCC AB14 Power/Other VCC AB18 Power/Other VCC AB24 Power/Other VCC **AB30** Power/Other VCC AC3 Power/Other VCC AC4 Power/Other VCC AC10 Power/Other VCC AC16 Power/Other VCC AC22 Power/Other VCC AC31 Power/Other VCC AD2 Power/Other VCC AD6 Power/Other VCC AD12 Power/Other VCC AD20 Power/Other VCC AD26 Power/Other VCC AD30 Power/Other VCC AE3 Power/Other VCC AE8 Power/Other VCC AE14 Power/Other

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
VCC	AE18	Power/Other	
VCC	AE24	Power/Other	
VCCA	AB4	Power/Other	Input
VCCIOPLL	AD4	Power/Other	Input
VCCSENSE	B27	Power/Other	Output
VID0	F3	Power/Other	Output
VID1	E3	Power/Other	Output
VID2	D3	Power/Other	Output
VID3	C3	Power/Other	Output
VID4	В3	Power/Other	Output
VSS	A5	Power/Other	
VSS	A11	Power/Other	
VSS	A21	Power/Other	
VSS	A27	Power/Other	
VSS	A29	Power/Other	
VSS	A31	Power/Other	
VSS	B2	Power/Other	
VSS	В9	Power/Other	
VSS	B15	Power/Other	
VSS	B17	Power/Other	
VSS	B23	Power/Other	
VSS	B28	Power/Other	
VSS	B30	Power/Other	
VSS	C1	Power/Other	
VSS	C7	Power/Other	
VSS	C13	Power/Other	
VSS	C19	Power/Other	
VSS	C25	Power/Other	
VSS	C29	Power/Other	
VSS	C31	Power/Other	
VSS	D2	Power/Other	
VSS	D5	Power/Other	
VSS	D11	Power/Other	
VSS	D21	Power/Other	
VSS	D27	Power/Other	
VSS	D28	Power/Other	
VSS	D30	Power/Other	
VSS	E1	Power/Other	
VSS	E9	Power/Other	



Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
VSS	E15	Power/Other	
VSS	E17	Power/Other	
VSS	E23	Power/Other	
VSS	E29	Power/Other	
VSS	E31	Power/Other	
VSS	F2	Power/Other	
VSS	F7	Power/Other	
VSS	F13	Power/Other	
VSS	F19	Power/Other	
VSS	F25	Power/Other	
VSS	F28	Power/Other	
VSS	F30	Power/Other	
VSS	G1	Power/Other	
VSS	G3	Power/Other	
VSS	G5	Power/Other	
VSS	G7	Power/Other	
VSS	G9	Power/Other	
VSS	G25	Power/Other	
VSS	G27	Power/Other	
VSS	G29	Power/Other	
VSS	G31	Power/Other	
VSS	H2	Power/Other	
VSS	H4	Power/Other	
VSS	H6	Power/Other	
VSS	H8	Power/Other	
VSS	H24	Power/Other	
VSS	H26	Power/Other	
VSS	H28	Power/Other	
VSS	H30	Power/Other	
VSS	J1	Power/Other	
VSS	J3	Power/Other	
VSS	J5	Power/Other	
VSS	J7	Power/Other	
VSS	J9	Power/Other	
VSS	J23	Power/Other	
VSS	J25	Power/Other	
VSS	J27	Power/Other	
VSS	J29	Power/Other	
VSS	J31	Power/Other	

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
VSS	K2	Power/Other	
VSS	K4	Power/Other	
VSS	K6	Power/Other	
VSS	K8	Power/Other	
VSS	K24	Power/Other	
VSS	K26	Power/Other	
VSS	K28	Power/Other	
VSS	K30	Power/Other	
VSS	L1	Power/Other	
VSS	L3	Power/Other	
VSS	L5	Power/Other	
VSS	L7	Power/Other	
VSS	L9	Power/Other	
VSS	L23	Power/Other	
VSS	L25	Power/Other	
VSS	L27	Power/Other	
VSS	L29	Power/Other	
VSS	L31	Power/Other	
VSS	M2	Power/Other	
VSS	M4	Power/Other	
VSS	M6	Power/Other	
VSS	M8	Power/Other	
VSS	M24	Power/Other	
VSS	M26	Power/Other	
VSS	M28	Power/Other	
VSS	M30	Power/Other	
VSS	N2	Power/Other	
VSS	N4	Power/Other	
VSS	N6	Power/Other	
VSS	N8	Power/Other	
VSS	N24	Power/Other	
VSS	N26	Power/Other	
VSS	N28	Power/Other	
VSS	N30	Power/Other	
VSS	P1	Power/Other	
VSS	P3	Power/Other	
VSS	P5	Power/Other	
VSS	P7	Power/Other	
VSS	P9	Power/Other	



Table 38. Pin Listing by Pin Name

Signal Pin Name Pin No. **Direction Buffer Type VSS** P23 Power/Other P25 Power/Other VSS VSS P27 Power/Other VSS P29 Power/Other Power/Other VSS P31 VSS R2 Power/Other VSS R4 Power/Other VSS R6 Power/Other Power/Other VSS R8 VSS R24 Power/Other VSS R26 Power/Other VSS R28 Power/Other VSS R30 Power/Other VSS T1 Power/Other VSS T3 Power/Other VSS T5 Power/Other VSS T7 Power/Other VSS T9 Power/Other VSS T23 Power/Other VSS T25 Power/Other VSS T27 Power/Other VSS T29 Power/Other VSS T31 Power/Other VSS U2 Power/Other VSS U4 Power/Other VSS U6 Power/Other VSS U8 Power/Other VSS U24 Power/Other VSS U26 Power/Other VSS U28 Power/Other VSS U30 Power/Other VSS V1 Power/Other VSS V3 Power/Other VSS V5 Power/Other VSS V7 Power/Other VSS V9 Power/Other VSS V23 Power/Other VSS V25 Power/Other VSS V27 Power/Other

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
VSS	V29	Power/Other	
VSS	V31	Power/Other	
VSS	W2	Power/Other	
VSS	W4	Power/Other	
VSS	W24	Power/Other	
VSS	W26	Power/Other	
VSS	W28	Power/Other	
VSS	W30	Power/Other	
VSS	Y1	Power/Other	
VSS	Y5	Power/Other	
VSS	Y7	Power/Other	
VSS	Y13	Power/Other	
VSS	Y19	Power/Other	
VSS	Y25	Power/Other	
VSS	Y31	Power/Other	
VSS	AA2	Power/Other	
VSS	AA9	Power/Other	
VSS	AA15	Power/Other	
VSS	AA17	Power/Other	
VSS	AA23	Power/Other	
VSS	AA30	Power/Other	
VSS	AB1	Power/Other	
VSS	AB5	Power/Other	
VSS	AB11	Power/Other	
VSS	AB21	Power/Other	
VSS	AB27	Power/Other	
VSS	AB31	Power/Other	
VSS	AC2	Power/Other	
VSS	AC7	Power/Other	
VSS	AC13	Power/Other	
VSS	AC19	Power/Other	
VSS	AC25	Power/Other	
VSS	AC30	Power/Other	
VSS	AD3	Power/Other	
VSS	AD9	Power/Other	
VSS	AD15	Power/Other	
VSS	AD17	Power/Other	
VSS	AD23	Power/Other	
VSS	AD31	Power/Other	



Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
VSS	AE2	Power/Other	
VSS	AE11	Power/Other	
VSS	AE21	Power/Other	
VSS	AE27	Power/Other	
VSSA	AA5	Power/Other	Input

Table 38. Pin Listing by Pin Name

Pin Name	Pin No.	Signal Buffer Type	Direction
VSSSENSE	D26	Power/Other	Output

- In systems utilizing the Intel Xeon processor, the system designer must pull-up these signals to the processor VCC
 Baseboard treating AA3 and AB3 as Reserved will operate correctly with a bus clock of 133 MHz.



4.1.2 Pin Listing by Pin Number

Table 39. Pin Listing by Pin Number

Table 39. Fill Listing by Fill Number			
Pin No.	Pin Name	Signal Buffer Type	Direction
A1	Reserved	Reserved	Reserved
A2	VCC	Power/Other	
A3	SKTOCC#	Power/Other	Output
A4	Reserved	Reserved	Reserved
A5	VSS	Power/Other	
A6	A32#	Source Sync	Input/Output
A7	A33#	Source Sync	Input/Output
A8	VCC	Power/Other	
A9	A26#	Source Sync	Input/Output
A10	A20#	Source Sync	Input/Output
A11	VSS	Power/Other	
A12	A14#	Source Sync	Input/Output
A13	A10#	Source Sync	Input/Output
A14	VCC	Power/Other	
A15	Reserved	Reserved	Reserved
A16	Reserved	Reserved	Reserved
A17	LOCK#	Common Clk	Input/Output
A18	VCC	Power/Other	
A19	A7#	Source Sync	Input/Output
A20	A4#	Source Sync	Input/Output
A21	VSS	Power/Other	
A22	A3#	Source Sync	Input/Output
A23	HITM#	Common Clk	Input/Output
A24	VCC	Power/Other	
A25	TMS	TAP	Input
A26	Reserved	Reserved	Reserved
A27	VSS	Power/Other	
A28	VCC	Power/Other	
A29	VSS	Power/Other	
A30	VCC	Power/Other	
A31	VSS	Power/Other	
B1	Reserved	Reserved	Reserved

Table 39. Pin Listing by Pin Number

Tubic 00.1 in Listing by 1 in Number			
Pin No.	Pin Name	Signal Buffer Type	Direction
B2	VSS	Power/Other	
В3	VID4	Power/Other	Output
B4	VCC	Power/Other	
B5	OTDEN	Power/Other	Input
В6	VCC	Power/Other	
B7	A31#	Source Sync	Input/Output
В8	A27#	Source Sync	Input/Output
В9	VSS	Power/Other	
B10	A21#	Source Sync	Input/Output
B11	A22#	Source Sync	Input/Output
B12	VCC	Power/Other	
B13	A13#	Source Sync	Input/Output
B14	A12#	Source Sync	Input/Output
B15	VSS	Power/Other	
B16	A11#	Source Sync	Input/Output
B17	VSS	Power/Other	
B18	A5#	Source Sync	Input/Output
B19	REQ0#	Common Clk	Input/Output
B20	VCC	Power/Other	
B21	REQ1#	Common Clk	Input/Output
B22	REQ4#	Common Clk	Input/Output
B23	VSS	Power/Other	
B24	LINT0	Async GTL+	Input
B25	PROCHOT#	Power/Other	Output
B26	VCC	Power/Other	
B27	VCCSENSE	Power/Other	Output
B28	VSS	Power/Other	
B29	VCC	Power/Other	
B30	VSS	Power/Other	
B31	VCC	Power/Other	
C1	VSS	Power/Other	
C2	VCC	Power/Other	
C3	VID3	Power/Other	Output



Table 39. Pin Listing by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Direction
C4	VCC	Power/Other	
C5	Reserved	Reserved	Reserved
C6	RSP#	Common Clk	Input
C7	VSS	Power/Other	
C8	A35#	Source Sync	Input/Output
C9	A34#	Source Sync	Input/Output
C10	VCC	Power/Other	
C11	A30#	Source Sync	Input/Output
C12	A23#	Source Sync	Input/Output
C13	VSS	Power/Other	
C14	A16#	Source Sync	Input/Output
C15	A15#	Source Sync	Input/Output
C16	VCC	Power/Other	
C17	A8#	Source Sync	Input/Output
C18	A6#	Source Sync	Input/Output
C19	VSS	Power/Other	
C20	REQ3#	Common Clk	Input/Output
C21	REQ2#	Common Clk	Input/Output
C22	VCC	Power/Other	
C23	DEFER#	Common Clk	Input
C24	TDI	TAP	Input
C25	VSS	Power/Other	Input
C26	IGNNE#	Async GTL+	Input
C27	SMI#	Async GTL+	Input
C28	VCC	Power/Other	
C29	VSS	Power/Other	
C30	VCC	Power/Other	
C31	VSS	Power/Other	
D1	VCC	Power/Other	
D2	VSS	Power/Other	
D3	VID2	Power/Other	Output
D4	STPCLK#	Async GTL+	Input
D5	VSS	Power/Other	
D6	INIT#	Async GTL+	Input
D7	MCERR#	Common Clk	Input/Output
D8	VCC	Power/Other	
D9	AP1#	Common Clk	Input/Output
D10	BR3# ¹	Common Clk	Input
D11	VSS	Power/Other	

Table 39. Pin Listing by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Direction
D12	A29#	Source Sync	Input/Output
D13	A25#	Source Sync	Input/Output
D14	VCC	Power/Other	
D15	A18#	Source Sync	Input/Output
D16	A17#	Source Sync	Input/Output
D17	A9#	Source Sync	Input/Output
D18	VCC	Power/Other	
D19	ADS#	Common Clk	Input/Output
D20	BR0#	Common Clk	Input/Output
D21	VSS	Power/Other	
D22	RS1#	Common Clk	Input
D23	BPRI#	Common Clk	Input
D24	VCC	Power/Other	
D25	Reserved	Reserved	Reserved
D26	VSSSENSE	Power/Other	Output
D27	VSS	Power/Other	
D28	VSS	Power/Other	
D29	VCC	Power/Other	
D30	VSS	Power/Other	
D31	VCC	Power/Other	
E1	VSS	Power/Other	
E2	VCC	Power/Other	
E3	VID1	Power/Other	Output
E4	BPM5#	Common Clk	Input/Output
E5	IERR#	Common Clk	Output
E6	VCC	Power/Other	
E7	BPM2#	Common Clk	Input/Output
E8	BPM4#	Common Clk	Input/Output
E9	VSS	Power/Other	
E10	AP0#	Common Clk	Input/Output
E11	BR2# ¹	Common Clk	Input
E12	VCC	Power/Other	
E13	A28#	Source Sync	Input/Output
E14	A24#	Source Sync	Input/Output
E15	VSS	Power/Other	
E16	COMP1	Power/Other	Input
E17	VSS	Power/Other	
E18	DRDY#	Common Clk	Input/Output



Table 39. Pin Listing by Pin Number

Table 33. Fill Listing by Fill Number			
Pin No.	Pin Name	Signal Buffer Type	Direction
E19	TRDY#	Common Clk	Input
E20	VCC	Power/Other	
E21	RS0#	Common Clk	Input
E22	HIT#	Common Clk	Input/Output
E23	VSS	Power/Other	
E24	TCK	TAP	Input
E25	TDO	TAP	Output
E26	VCC	Power/Other	
E27	FERR#	Async GTL+	Output
E28	VCC	Power/Other	
E29	VSS	Power/Other	
E30	VCC	Power/Other	
E31	VSS	Power/Other	
F1	VCC	Power/Other	
F2	VSS	Power/Other	
F3	VID0	Power/Other	Output
F4	VCC	Power/Other	
F5	BPM3#	Common Clk	Input/Output
F6	BPM0#	Common Clk	Input/Output
F7	VSS	Power/Other	
F8	BPM1#	Common Clk	Input/Output
F9	GTLREF	Power/Other	Input
F10	VCC	Power/Other	
F11	BINIT#	Common Clk	Input/Output
F12	BR1#	Common Clk	Input
F13	VSS	Power/Other	
F14	ADSTB1#	Source Sync	Input/Output
F15	A19#	Source Sync	Input/Output
F16	VCC	Power/Other	
F17	ADSTB0#	Source Sync	Input/Output
F18	DBSY#	Common Clk	Input/Output
F19	VSS	Power/Other	
F20	BNR#	Common Clk	Input/Output
F21	RS2#	Common Clk	Input
F22	VCC	Power/Other	
F23	GTLREF	Power/Other	Input
F24	TRST#	TAP	Input
F25	VSS	Power/Other	
F26	THERMTRIP #	Async GTL+	Output

Table 39. Pin Listing by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Direction
F27	A20M#	Async GTL+	Input
F28	VSS	Power/Other	<u> </u>
F29	VCC	Power/Other	
F30	VSS	Power/Other	
F31	VCC	Power/Other	
G1	VSS	Power/Other	
G2	VCC	Power/Other	
G3	VSS	Power/Other	
G4	VCC	Power/Other	
G5	VSS	Power/Other	
G6	VCC	Power/Other	
G7	VSS	Power/Other	
G8	VCC	Power/Other	
G9	VSS	Power/Other	
G23	LINT1	Async GTL+	Input
G24	VCC	Power/Other	
G25	VSS	Power/Other	
G26	VCC	Power/Other	
G27	VSS	Power/Other	
G28	VCC	Power/Other	
G29	VSS	Power/Other	
G30	VCC	Power/Other	
G31	VSS	Power/Other	
H1	VCC	Power/Other	
H2	VSS	Power/Other	
НЗ	VCC	Power/Other	
H4	VSS	Power/Other	
H5	VCC	Power/Other	
H6	VSS	Power/Other	
H7	VCC	Power/Other	
H8	VSS	Power/Other	
H9	VCC	Power/Other	
H23	VCC	Power/Other	
H24	VSS	Power/Other	
H25	VCC	Power/Other	
H26	VSS	Power/Other	
H27	VCC	Power/Other	
H28	VSS	Power/Other	
H29	VCC	Power/Other	



Table 39. Pin Listing by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Direction
H30	VSS	Power/Other	
H31	VCC	Power/Other	
J1	VSS	Power/Other	
J2	VCC	Power/Other	
J3	VSS	Power/Other	
J4	VCC	Power/Other	
J5	VSS	Power/Other	
J6	VCC	Power/Other	
J7	VSS	Power/Other	
J8	VCC	Power/Other	
J9	VSS	Power/Other	
J23	VSS	Power/Other	
J24	VCC	Power/Other	
J25	VSS	Power/Other	
J26	VCC	Power/Other	
J27	VSS	Power/Other	
J28	VCC	Power/Other	
J29	VSS	Power/Other	
J30	VCC	Power/Other	
J31	VSS	Power/Other	
K1	VCC	Power/Other	
K2	VSS	Power/Other	
K3	VCC	Power/Other	
K4	VSS	Power/Other	
K5	VCC	Power/Other	
K6	VSS	Power/Other	
K7	VCC	Power/Other	
K8	VSS	Power/Other	
K9	VCC	Power/Other	
K23	VCC	Power/Other	
K24	VSS	Power/Other	
K25	VCC	Power/Other	
K26	VSS	Power/Other	
K27	VCC	Power/Other	
K28	VSS	Power/Other	
K29	VCC	Power/Other	
K30	VSS	Power/Other	
K31	VCC	Power/Other	
L1	VSS	Power/Other	

Table 39. Pin Listing by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Direction
L2	VCC	Power/Other	
L3	VSS	Power/Other	
L4	VCC	Power/Other	
L5	VSS	Power/Other	
L6	VCC	Power/Other	
L7	VSS	Power/Other	
L8	VCC	Power/Other	
L9	VSS	Power/Other	
L23	VSS	Power/Other	
L24	VCC	Power/Other	
L25	VSS	Power/Other	
L26	VCC	Power/Other	
L27	VSS	Power/Other	
L28	VCC	Power/Other	
L29	VSS	Power/Other	
L30	VCC	Power/Other	
L31	VSS	Power/Other	
M1	VCC	Power/Other	
M2	VSS	Power/Other	
M3	VCC	Power/Other	
M4	VSS	Power/Other	
M5	VCC	Power/Other	
M6	VSS	Power/Other	
M7	VCC	Power/Other	
M8	VSS	Power/Other	
M9	VCC	Power/Other	
M23	VCC	Power/Other	
M24	VSS	Power/Other	
M25	VCC	Power/Other	
M26	VSS	Power/Other	
M27	VCC	Power/Other	
M28	VSS	Power/Other	
M29	VCC	Power/Other	
M30	VSS	Power/Other	
M31	VCC	Power/Other	
N1	VCC	Power/Other	
N2	VSS	Power/Other	
N3	VCC	Power/Other	
N4	VSS	Power/Other	



Table 39. Pin Listing by Pin NumberTable 39. Pin Listing by Pin Number

Table 39. Pill Listing by Pill Number			
Pin No.	Pin Name	Signal Buffer Type	Direction
N5	VCC	Power/Other	
N6	VSS	Power/Other	
N7	VCC	Power/Other	
N8	VSS	Power/Other	
N9	VCC	Power/Other	
N23	VCC	Power/Other	
N24	VSS	Power/Other	
N25	VCC	Power/Other	
N26	VSS	Power/Other	
N27	VCC	Power/Other	
N28	VSS	Power/Other	
N29	VCC	Power/Other	
N30	VSS	Power/Other	
N31	VCC	Power/Other	
P1	VSS	Power/Other	
P2	VCC	Power/Other	
P3	VSS	Power/Other	
P4	VCC	Power/Other	
P5	VSS	Power/Other	
P6	VCC	Power/Other	
P7	VSS	Power/Other	
P8	VCC	Power/Other	
P9	VSS	Power/Other	
P23	VSS	Power/Other	
P24	VCC	Power/Other	
P25	VSS	Power/Other	
P26	VCC	Power/Other	
P27	VSS	Power/Other	
P28	VCC	Power/Other	
P29	VSS	Power/Other	
P30	VCC	Power/Other	
P31	VSS	Power/Other	
R1	VCC	Power/Other	
R2	VSS	Power/Other	
R3	VCC	Power/Other	
R4	VSS	Power/Other	
R5	VCC	Power/Other	
R6	VSS	Power/Other	
R7	VCC	Power/Other	
	•	•	

Pin No.	Pin Name	Signal Buffer Type	Direction
R8	VSS	Power/Other	
R9	VCC	Power/Other	
R23	VCC	Power/Other	
R24	VSS	Power/Other	
R25	VCC	Power/Other	
R26	VSS	Power/Other	
R27	VCC	Power/Other	
R28	VSS	Power/Other	
R29	VCC	Power/Other	
R30	VSS	Power/Other	
R31	VCC	Power/Other	
T1	VSS	Power/Other	
T2	VCC	Power/Other	
Т3	VSS	Power/Other	
T4	VCC	Power/Other	
T5	VSS	Power/Other	
Т6	VCC	Power/Other	
T7	VSS	Power/Other	
Т8	VCC	Power/Other	
Т9	VSS	Power/Other	
T23	VSS	Power/Other	
T24	VCC	Power/Other	
T25	VSS	Power/Other	
T26	VCC	Power/Other	
T27	VSS	Power/Other	
T28	VCC	Power/Other	
T29	VSS	Power/Other	
T30	VCC	Power/Other	
T31	VSS	Power/Other	
U1	VCC	Power/Other	
U2	VSS	Power/Other	
U3	VCC	Power/Other	
U4	VSS	Power/Other	
U5	VCC	Power/Other	
U6	VSS	Power/Other	
U7	VCC	Power/Other	
U8	VSS	Power/Other	
U9	VCC	Power/Other	
U23	VCC	Power/Other	



Table 39. Pin Listing by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Direction
U24	VSS	Power/Other	
U25	VCC	Power/Other	
U26	VSS	Power/Other	
U27	VCC	Power/Other	
U28	VSS	Power/Other	
U29	VCC	Power/Other	
U30	VSS	Power/Other	
U31	VCC	Power/Other	
V1	VSS	Power/Other	
V2	VCC	Power/Other	
V3	VSS	Power/Other	
V4	VCC	Power/Other	
V5	VSS	Power/Other	
V6	VCC	Power/Other	
V7	VSS	Power/Other	
V8	VCC	Power/Other	
V9	VSS	Power/Other	
V23	VSS	Power/Other	
V24	VCC	Power/Other	
V25	VSS	Power/Other	
V26	VCC	Power/Other	
V27	VSS	Power/Other	
V28	VCC	Power/Other	
V29	VSS	Power/Other	
V30	VCC	Power/Other	
V31	VSS	Power/Other	
W1	VCC	Power/Other	
W2	VSS	Power/Other	
W3	Reserved	Reserved	Reserved
W4	VSS	Power/Other	
W5	BCLK1	Sys Bus Clk	Input
W6	TESTHI0	Power/Other	Input
W7	TESTHI1	Power/Other	Input
W8	TESTHI2	Power/Other	Input
W9	GTLREF	Power/Other	Input
W23	GTLREF	Power/Other	Input
W24	VSS	Power/Other	
W25	VCC	Power/Other	
W26	VSS	Power/Other	

Table 39. Pin Listing by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Direction
W27	VCC	Power/Other	
W28	VSS	Power/Other	
W29	VCC	Power/Other	
W30	VSS	Power/Other	
W31	VCC	Power/Other	
Y1	VSS	Power/Other	
Y2	VCC	Power/Other	
Y3	Reserved	Reserved	Reserved
Y4	BCLK0	Sys Bus Clk	Input
Y5	VSS	Power/Other	
Y6	TESTHI3	Power/Other	Input
Y7	VSS	Power/Other	
Y8	RESET#	Common Clk	Input
Y9	D62#	Source Sync	Input/Output
Y10	VCC	Power/Other	
Y11	DSTBP3#	Source Sync	Input/Output
Y12	DSTBN3#	Source Sync	Input/Output
Y13	VSS	Power/Other	
Y14	DSTBP2#	Source Sync	Input/Output
Y15	DSTBN2#	Source Sync	Input/Output
Y16	VCC	Power/Other	
Y17	DSTBP1#	Source Sync	Input/Output
Y18	DSTBN1#	Source Sync	Input/Output
Y19	VSS	Power/Other	
Y20	DSTBP0#	Source Sync	Input/Output
Y21	DSTBN0#	Source Sync	Input/Output
Y22	VCC	Power/Other	
Y23	D5#	Source Sync	Input/Output
Y24	D2#	Source Sync	Input/Output
Y25	VSS	Power/Other	
Y26	D0#	Source Sync	Input/Output
Y27	THERMDA	Anode Pin	Output
Y28	THERMDC	Cathode Pin	Output
Y29	NC	Reserved	
Y30	VCC	Power/Other	
Y31	VSS	Power/Other	
AA1	VCC	Power/Other	
AA2	VSS	Power/Other	
AA3	BSEL0	Power/Other	Output ²



Table 39. Pin Listing by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Direction	
AA4	VCC	Power/Other		
AA5	VSSA	Power/Other	Input	
AA6	VCC	Power/Other		
AA7	TESTHI4	Power/Other	Input	
AA8	D61#	Source Sync	Input/Output	
AA9	VSS	Power/Other		
AA10	D54#	Source Sync	Input/Output	
AA11	D53#	Source Sync	Input/Output	
AA12	VCC	Power/Other		
AA13	D48#	Source Sync	Input/Output	
AA14	D49#	Source Sync	Input/Output	
AA15	VSS	Power/Other		
AA16	D33#	Source Sync	Input/Output	
AA17	VSS	Power/Other		
AA18	D24#	Source Sync	Input/Output	
AA19	D15#	Source Sync	Input/Output	
AA20	VCC	Power/Other		
AA21	D11#	Source Sync	Input/Output	
AA22	D10#	Source Sync	Input/Output	
AA23	VSS	Power/Other		
AA24	D6#	Source Sync	Input/Output	
AA25	D3#	Source Sync	Input/Output	
AA26	VCC	Power/Other		
AA27	D1#	Source Sync	Input/Output	
AA28	NC	Reserved		
AA29	NC	Reserved		
AA30	VSS	Power/Other		
AA31	VCC	Power/Other		
AB1	VSS	Power/Other		
AB2	VCC	Power/Other		
AB3	BSEL1	Power/Other	Output ²	
AB4	VCCA	Power/Other	Input	
AB5	VSS	Power/Other		
AB6	D63#	Source Sync		
AB7	PWRGOOD	Power/Other	Input	
AB8	VCC	Power/Other		
AB9	DBI3#	Source Sync	Input/Output	
AB10	D55#	Source Sync	Input/Output	
AB11	VSS	Power/Other		

Table 39. Pin Listing by Pin Number

		Signal		
Pin No.	Pin Name	Buffer Type	Direction	
AB12	D51#	Source Sync	Input/Output	
AB13	D52#	Source Sync	Input/Output	
AB14	VCC	Power/Other		
AB15	D37#	Source Sync	Input/Output	
AB16	D32#	Source Sync	Input/Output	
AB17	D31#	Source Sync	Input/Output	
AB18	VCC	Power/Other		
AB19	D14#	Source Sync	Input/Output	
AB20	D12#	Source Sync	Input/Output	
AB21	VSS	Power/Other		
AB22	D13#	Source Sync	Input/Output	
AB23	D9#	Source Sync	Input/Output	
AB24	VCC	Power/Other		
AB25	D8#	Source Sync	Input/Output	
AB26	D7#	Source Sync	Input/Output	
AB27	VSS	Power/Other		
AB28	NC	Reserved		
AB29	NC	Reserved		
AB30	VCC	Power/Other		
AB31	VSS	Power/Other		
AC1	Reserved	Reserved	Reserved	
AC2	VSS	Power/Other		
AC3	VCC	Power/Other		
AC4	VCC	Power/Other		
AC5	D60#	Source Sync	Input/Output	
AC6	D59#	Source Sync	Input/Output	
AC7	VSS	Power/Other		
AC8	D56#	Source Sync	Input/Output	
AC9	D47#	Source Sync	Input/Output	
AC10	VCC	Power/Other		
AC11	D43#	Source Sync	Input/Output	
AC12	D41#	Source Sync	Input/Output	
AC13	VSS	Power/Other		
AC14	D50#	Source Sync	Input/Output	
AC15	DP2#	Common Clk	Input/Output	
AC16	VCC	Power/Other		
AC17	D34#	Source Sync	Input/Output	
AC18	DP0#	Common Clk	Input/Output	
AC19	VSS	Power/Other		



Table 39. Pin Listing by Pin Number

	1	1	
Pin No.	Pin Name	Signal Buffer Type	Direction
AC20	D25#	Source Sync	Input/Output
AC21	D26#	Source Sync	Input/Output
AC22	VCC	Power/Other	
AC23	D23#	Source Sync	Input/Output
AC24	D20#	Source Sync	Input/Output
AC25	VSS	Power/Other	
AC26	D17#	Source Sync	Input/Output
AC27	DBI0#	Source Sync	Input/Output
AC28	NC	Reserved	
AC29	NC	Reserved	
AC30	VSS	Power/Other	
AC31	VCC	Power/Other	
AD1	Reserved	Reserved	Reserved
AD2	VCC	Power/Other	
AD3	VSS	Power/Other	
AD4	VCCIOPLL	Power/Other	Input
AD5	TESTHI5	Power/Other	Input
AD6	VCC	Power/Other	
AD7	D57#	Source Sync	Input/Output
AD8	D46#	Source Sync	Input/Output
AD9	VSS	Power/Other	
AD10	D45#	Source Sync	Input/Output
AD11	D40#	Source Sync	Input/Output
AD12	VCC	Power/Other	
AD13	D38#	Source Sync	Input/Output
AD14	D39#	Source Sync	Input/Output
AD15	VSS	Power/Other	
AD16	COMP0	Power/Other	Input
AD17	VSS	Power/Other	
AD18	D36#	Source Sync	Input/Output
AD19	D30#	Source Sync	Input/Output
AD20	VCC	Power/Other	
AD21	D29#	Source Sync	Input/Output
AD22	DBI1#	Source Sync	Input/Output
AD23	VSS	Power/Other	
AD24	D21#	Source Sync	Input/Output
AD25	D18#	Source Sync	Input/Output
AD26	VCC	Power/Other	
	l .	1	

Table 39. Pin Listing by Pin Number

Pin No.	Pin Name	Signal Buffer Type	Direction
AD27	D4#	Source Sync	Input/Output
AD28	NC	Reserved	
AD29	NC	Reserved	
AD30	VCC	Power/Other	
AD31	VSS	Power/Other	
AE2	VSS	Power/Other	
AE3	VCC	Power/Other	
AE4	SMD_PRT	Ground	Output
AE5	TESTHI6	Power/Other	Input
AE6	SLP#	Async GTL+	Input
AE7	D58#	Source Sync	Input/Output
AE8	VCC	Power/Other	
AE9	D44#	Source Sync	Input/Output
AE10	D42#	Source Sync	Input/Output
AE11	VSS	Power/Other	
AE12	DBI2#	Source Sync	Input/Output
AE13	D35#	Source Sync	Input/Output
AE14	VCC	Power/Other	
AE15	Reserved	Reserved	Reserved
AE16	Reserved	Reserved	Reserved
AE17	DP3#	Common Clk	Input/Output
AE18	VCC	Power/Other	
AE19	DP1#	Common Clk	Input/Output
AE20	D28#	Source Sync	Input/Output
AE21	VSS	Power/Other	
AE22	D27#	Source Sync	Input/Output
AE23	D22#	Source Sync	Input/Output
AE24	VCC	Power/Other	
AE25	D19#	Source Sync	Input/Output
AE26	D16#	Source Sync	Input/Output
AE27	VSS	Power/Other	
AE28	VID_V _{CC}	Power/Other	
AE29	VID_V _{CC}	Power/Other	
AE30	Mechanical Key		

In systems utilizing the Intel Xeon processor, the system designer must pull-up these signals to the processor VCC.
 Baseboards treating AA3 and AB3 as Reserved will operate correctly with a bus clock of 133 MHz.







4.2 Signal Definitions

Table 41. Signal Definitions (Sheet 1 of 9)

Name	Туре	Des	cription		Notes			
A[35:3]#	I/O	1 of the address phase, these pins traphase 2, these pins transmit transactionnect the appropriate pins of all a protected by parity signals AP[1:0]#. A are latched into the receiving buffers by	35:3]# (Address) define a 2 ³⁶ byte physical memory address space. In sub-phase of the address phase, these pins transmit the address of a transaction. In sub-ase 2, these pins transmit transaction type information. These signals must nnect the appropriate pins of all agents on the front side bus. A[35:3]# are otected by parity signals AP[1:0]#. A[35:3]# are source synchronous signals and e latched into the receiving buffers by ADSTB[1:0]#.					
		On the active-to-inactive transition of R the A[35:3]# pins to determine their pov						
A20M#	I	F A20M# (Address-20 Mask) is asserted, the processor masks physical address bit 20 (A20#) before looking up a line in any internal cache and before driving a read/vrite transaction on the bus. Asserting A20M# emulates the 8086 processor's address wrap-around at the 1 MByte boundary. Assertion of A20M# is only supported in real mode. A20M# is an asynchronous signal. However, to ensure recognition of this signal collowing an I/O write instruction, it must be valid along with the TRDY# assertion of the corresponding I/O write bus transaction.						
ADS#	I/O	ADS# (Address Strobe) is asserted to indicate the validity of the transaction address on the A[35:3]# pins. All bus agents observe the ADS# activation to begin parity checking, protocol checking, address decode, internal snoop, or deferred reply ID match operations associated with the new transaction. This signal must connect the appropriate pins on all front side bus agents.						
ADSTB[1:0]#	I/O	Address strobes are used to latch A[35 edge.	Address strobes are used to latch A[35:3]# and REQ[4:0]# on their rising and falling edge.					
AP[1:0]#	1/0	AP[1:0]# (Address Parity) are driven A[35:3]#, and the transaction type on thigh if an even number of covered signals are low. This allows pare high. AP[1:0]# should connect the The following table defines the coverage	ne REQ[4:0]# pins. gnals are low and learity to be high when appropriate pins of a	A correct parity signal is ow if an odd number of all the covered signals all front side bus agents.	4			
		A[35:24]#	AP0#	AP1#				
		A[23:3]#	AP1#	AP0#				
		REQ[4:0]#	AP1#	AP0#				
BCLK[1:0]	I	The differential pair BCLK (Bus Clock) front side bus agents must receive the their inputs. All external timing parameters are sp BCLK0 crossing the falling edge of BCl	ese signals to drive	their outputs and latch	4			



Table 41. Signal Definitions (Sheet 2 of 9)

Name	Type	Description	Notes
		BINIT# (Bus Initialization) may be observed and driven by all processor front side bus agents and if used, must connect the appropriate pins of all such agents. If the BINIT# driver is enabled during power on configuration, BINIT# is asserted to signal any bus condition that prevents reliable future information.	
BINIT#	I/O	If BINIT# observation is enabled during power-on configuration (see Section 6.1) and BINIT# is sampled asserted, symmetric agents reset their bus LOCK# activity and bus request arbitration state machines. The bus agents do not reset their IOQ and transaction tracking state machines upon observation of BINIT# assertion. Once the BINIT# assertion has been observed, the bus agents will re-arbitrate for the front side bus and attempt completion of their bus queue and IOQ entries.	4
		If BINIT# observation is disabled during power-on configuration, a central agent may handle an assertion of BINIT# as appropriate to the error handling architecture of the system.	
		BNR# (Block Next Request) is used to assert a bus stall by any bus agent who is unable to accept new bus transactions. During a bus stall, the current bus owner cannot issue any new transactions.	
BNR#	I/O	Since multiple agents might need to request a bus stall at the same time, BNR# is a wire-OR signal which must connect the appropriate pins of all processor front side bus agents. In order to avoid wire-OR glitches associated with simultaneous edge transitions driven by multiple drivers, BNR# is activated on specific clock edges and sampled on specific clock edges.	4
		BPM[5:0]# (Breakpoint Monitor) are breakpoint and performance monitor signals. They are outputs from the processor which indicate the status of breakpoints and programmable counters used for monitoring processor performance. BPM[5:0]# should connect the appropriate pins of all front side bus agents.	
		BPM4# provides PRDY# (Probe Ready) functionality for the TAP port. PRDY# is a processor output used by debug tools to determine processor debug readiness.	
BPM[5:0]#	I/O	BPM5# provides PREQ# (Probe Request) functionality for the TAP port. PREQ# is used by debug tools to request debug operation of the processors.	3
		BPM[5:4]# must be bussed to all bus agents.	
		These signals do not have on-die termination and must be terminated at the end agent. See the appropriate platform design guidelines for additional information.	
BPRI#	I	BPRI# (Bus Priority Request) is used to arbitrate for ownership of the processor front side bus. It must connect the appropriate pins of all processor front side bus agents. Observing BPRI# active (as asserted by the priority agent) causes all other agents to stop issuing new requests, unless such requests are part of an ongoing locked operation. The priority agent keeps BPRI# asserted until all of its requests are completed, then releases the bus by deasserting BPRI#.	4



Table 41. Signal Definitions (Sheet 3 of 9)

Name	Туре			Descri	iption			Notes
BR0# BR[1:3]# ¹	I/O I	BR[3:0]# (Bus Request) drive the BREQ[3:0]# signals in the system. The BREQ[3:0]# signals are interconnected in a rotating manner to individual processor pins. BR2# and BR3# must not be utilized in a dual processor platform design. The table below gives the rotating interconnect between the processor and bus signals for dual processor systems. BR[1:0]# Signals Rotating Interconnect, dual processor system Bus Signal Agent 0 Pins Agent 1 Pins BREQ0# BR0# BR1# BREQ1# BR1# BR0# During power-up configuration, the central agent must assert the BR0# bus signal. All symmetric agents sample their BR[1:0]# pins on active-to-inactive transition of RESET#. The pin on which the agent samples an active level determines its agent ID. All agents then configure their pins to match the appropriate bus signal protoco as shown below. BR[1:0]# Signal Agent IDs BR[1:0]# Signals Rotating Interconnect, dual processor system BR0# 0					idual processor and design. The and bus signals and bus signals are transition of mines its agent	1,4
		During power-or	BR1#	ne centra	I agent n	1 must assert the BI	R0# hus signal	
		All symmetric ag of RESET#. The	ents sample the pin which the ag	ir BR[3:0] gent samp]# pins o	n the active-to-ina erted determines i	active transition t's agent ID.	
						and must be teri sign guidelines		
DOEL (4-2)		"00" will select a processor(s), chagents must ope	100 MHz bus clo lipset, and frequ	ock frequo uency syr frequence	ency. The othesizer cy. Individ	de bus frequency e frequency is det r capabilities. All dual processors w	termined by the front side bus	
BSEL[1:0]	0		On baseboards e			00 MHz bus clock e of these signals,		
		See Table 2 "From page 13 for outp		ck Freque	ency Sele	ect Truth Table for	r BSEL[1:0]" on	
COMP[1:0]	I	These inputs cor	nfigure the AGTL	+ drivers	of the pro	eboard using predocessor. Refer to nentation details.		



Table 41. Signal Definitions (Sheet 4 of 9)

Name	Туре			Description		Notes
		between the procepins on all such a transfer. D[63:0]# are quad-clock period. D[63 DSTBN[3:0]#. Eacl	essor front side gents. The data pumped signals :0]# are latched in group of 16 da	bus agents, driver asser , and will thu off the fallinata signals co	signals provide a 64-bit data path and must connect the appropriate ts DRDY# to indicate a valid data as be driven four times in a common gedge of both DSTBP[3:0]# and prespond to a pair of one DSTBP# e grouping of data signals to strobes	
D[63:0]#	I/O	Data Group	DSTBN/ DSTBP	DBI#		4
		D[15:0]#	0	0		
		D[31:16]#	1	1		
		D[47:32]#	2	2		
		D[63:48]#	3	3		
		of 16 data signals	corresponds to c	ne DBI# sigr	rity of the data signals. Each group nal. When the DBI# signal is active, erefore sampled active high.	
		The DBI[3:0]# sign	als are activated int the data bus s c level in the nex	I when the da signals if mo at cycle.	the polarity of the D[63:0]# signals. ata on the data bus is inverted. The re than half the bits, within a 16-bit	
DBI[3:0]#	I/O	Bus Signal	Data Bus	Signals		4
		DBI0#	D[15	5:0]#		
		DBI1#	D[31:	:16]#		
		DBI2#	D[47	:32]#		
		DBI3#	D[63:	:48]#		
DBSY#	I/O	processor front sic	le bus to indicate Y# is deasserted	te that the d d. This signa	It responsible for driving data on the ata bus is in use. The data bus is I must connect the appropriate pins	4
DEFER#	I	guaranteed in-orde	er completion. As memory or I/O a	sertion of DE gent. This si	ate that a transaction cannot be EFER# is normally the responsibility gnal must connect the appropriate	4
1		DP[3:0]# (Data Parity) provide parity protection for the D[63:0]# signals. They are driven by the agent responsible for driving D[63:0]#, and must connect the appropriate pins of all processor front side bus agents.				
DP[3:0]#	I/O	driven by the age	ent responsible	for driving	D[63:0]#, and must connect the	4
DP[3:0]# DRDY#	1/0	driven by the agrappropriate pins of DRDY# (Data Reindicating valid data	ent responsible all processor fro ady) is asserte a on the data bus d to insert idle o	for driving ont side bus and by the distribution of the distribution of the distribution of the driving of the	D[63:0]#, and must connect the	4
		driven by the agrappropriate pins of DRDY# (Data Reindicating valid data may be deasserted	ent responsible all processor fro ady) is asserte a on the data bus d to insert idle cor front side bus	for driving out side bus and by the day. In a multi-clocks. This sagents.	D[63:0]#, and must connect the agents. ata driver on each data transfer, ommon clock data transfer, DRDY#	



Table 41. Signal Definitions (Sheet 5 of 9)

Name	Type	Description	Notes
FERR#/PBE#	0	FERR#/PBE# (floating point error/pending break event) is a multiplexed signal and its meaning is qualified by STPCLK#. When STPCLK# is not asserted, FERR#/PBE# indicates a floating-point error and will be asserted when the processor detects an unmasked floating-point error. When STPCLK# is not asserted, FERR#/PBE# is similar to the ERROR# signal on the Intel 387 coprocessor, and is included for compatibility with systems using MS-DOS*-type floating-point error reporting. When STPCLK# is asserted, an assertion of FERR#/PBE# indicates that the processor has a pending break event waiting for service. The assertion of FERR#/PBE# indicates that the processor should be returned to the Normal state. For additional information on the pending break event functionality, including the identification of support of the feature and enable/disable information, refer to volume 3 of the Intel Architecture Software Developer's Manual and the Intel Processor Identification and the CPUID Instruction application note.	3
		This signal does not have on-die termination and must be terminated at the end agent. See the appropriate Platform Design Guideline for additional information.	
GTLREF	I	GTLREF determines the signal reference level for AGTL+ input pins. GTLREF should be set at 2/3Vcc. GTLREF is used by the AGTL+ receivers to determine if a signal is a logical 0 or a logical 1.	
HIT# HITM#	1/O 1/O	HIT# (Snoop Hit) and HITM# (Hit Modified) convey transaction snoop operation results. Any front side bus agent may assert both HIT# and HITM# together to indicate that it requires a snoop stall, which can be continued by reasserting HIT# and HITM# together. Since multiple agents may deliver snoop results at the same time, HIT# and HITM# are wire-OR signals which must connect the appropriate pins of all processor front side bus agents. In order to avoid wire-OR glitches associated with simultaneous edge transitions driven by multiple drivers, HIT# and HITM# are activated on specific clock edges and sampled on specific clock edges.	4
IERR#	0	IERR# (Internal Error) is asserted by a processor as the result of an internal error. Assertion of IERR# is usually accompanied by a SHUTDOWN transaction on the processor front side bus. This transaction may optionally be converted to an external error signal (e.g., NMI) by system core logic. The processor will keep IERR# asserted until the assertion of RESET#, BINIT#, or INIT#. This signal does not have on-die termination and must be terminated at the end agent. See the appropriate Platform Design Guideline for additional	3
IGNNE#	ı	information. IGNNE# (Ignore Numeric Error) is asserted to force the processor to ignore a numeric error and continue to execute noncontrol floating-point instructions. If IGNNE# is deasserted, the processor generates an exception on a noncontrol floating-point instruction if a previous floating-point instruction caused an error. IGNNE# has no effect when the NE bit in control register 0 (CR0) is set. IGNNE# is an asynchronous signal. However, to ensure recognition of this signal following an I/O write instruction, it must be valid along with the TRDY# assertion of the corresponding I/O write bus transaction.	3
INIT#	I	INIT# (Initialization), when asserted, resets integer registers inside all processors without affecting their internal caches or floating-point registers. Each processor then begins execution at the power-on Reset vector configured during power-on configuration. The processor continues to handle snoop requests during INIT# assertion. INIT# is an asynchronous signal and must connect the appropriate pins of all processor front side bus agents. If INIT# is sampled active on the active to inactive transition of RESET#, then the processor executes its Built-in Self-Test (BIST).	3



Table 41. Signal Definitions (Sheet 6 of 9)

Name	Type	Description	Notes
LINT[1:0]	ı	LINT[1:0] (Local APIC Interrupt) must connect the appropriate pins of all front side bus agents. When the APIC functionality is disabled, the LINT0 signal becomes INTR, a maskable interrupt request signal, and LINT1 becomes NMI, a nonmaskable interrupt. INTR and NMI are backward compatible with the signals of those names on the Pentium processor. Both signals are asynchronous.	3
		Both of these signals must be software configured via BIOS programming of the APIC register space to be used either as NMI/INTR or LINT[1:0]. Because the APIC is enabled by default after Reset, operation of these pins as LINT[1:0] is the default configuration.	
1.00/4	I/O	LOCK# indicates to the system that a transaction must occur atomically. This signal must connect the appropriate pins of all processor front side bus agents. For a locked sequence of transactions, LOCK# is asserted from the beginning of the first transaction to the end of the last transaction.	4
LOCK#	1/0	When the priority agent asserts BPRI# to arbitrate for ownership of the processor front side bus, it will wait until it observes LOCK# deasserted. This enables symmetric agents to retain ownership of the processor front side bus throughout the bus locked operation and ensure the atomicity of lock.	4
Mechanical Key	Inert	Mechanical Key to prevent compatibility with 603-pin socket.	
MCERR#	I/O	 MCERR# (Machine Check Error) is asserted to indicate an unrecoverable error without a bus protocol violation. It may be driven by all processor front side bus agents. MCERR# assertion conditions are configurable at a system level. Assertion options are defined by the following options: Enabled or disabled. Asserted, if configured, for internal errors along with IERR#. Asserted, if configured, by the request initiator of a bus transaction after it observes an error. Asserted by any bus agent when it observes an error in a bus transaction. For more details regarding machine check architecture, refer to the IA-32 Software Developer's Manual, Volume 3: System Programming Guide. Since multiple agents may drive this signal at the same time, MCERR# is a wire-OR signal which must connect the appropriate pins of all processor front side bus agents. In order to avoid wire-OR glitches associated with simultaneous edge transitions driven by multiple drivers, MCERR# is activated on specific clock edges and sampled on specific clock edges. 	
ODTEN	I	ODTEN (On-die termination enable) should be connected to $V_{\rm CC}$ to enable on-die termination for end bus agents. For middle bus agents, pull this signal down via a resistor to ground to disable on-die termination. Whenever ODTEN is high, on-die termination will be active, regardless of other states of the bus.	
PROCHOT#	0	PROCHOT# (processor hot) indicates that the processor Thermal Control Circuit (TCC) has been activated. Under most conditions, PROCHOT# will go active when the processor's thermal sensor detects that the processor has reached its maximum safe operating temperature. See Section 6.3 for more details. These signals do not have on-die termination and must be terminated at the end agent. See the appropriate Platform Design Guideline for additional	
		information.	



Table 41. Signal Definitions (Sheet 7 of 9)

Name	Type	Description	Notes
PWRGOOD	ı	PWRGOOD (Power Good) is an input. The processor requires this signal to be a clean indication that all processor clocks and power supplies are stable and within their specifications. "Clean" implies that the signal will remain low (capable of sinking leakage current), without glitches, from the time that the power supplies are turned on until they come within specification. The signal must then transition monotonically to a high state. Figure 6 illustrates the relationship of PWRGOOD to the RESET# signal. PWRGOOD can be driven inactive at any time, but clocks and power must again be stable before a subsequent rising edge of PWRGOOD. It must also meet the minimum pulse width specification in Table 13, and be followed by a 1 mS RESET# pulse. The PWRGOOD signal must be supplied to the processor; it is used to protect internal circuits against voltage sequencing issues. It should be driven high throughout boundary scan operation.	3
REQ[4:0]#	1/0	REQ[4:0]# (Request Command) must connect the appropriate pins of all processor front side bus agents. They are asserted by the current bus owner to define the currently active transaction type. These signals are source synchronous to ADSTB[1:0]#. Refer to the AP[1:0]# signal description for details on parity checking of these signals.	4
RESET#	ı	Asserting the RESET# signal resets all processors to known states and invalidates their internal caches without writing back any of their contents. For a power-on Reset, RESET# must stay active for at least one millisecond after Vcc and BCLK have reached their proper specifications. On observing active RESET#, all front side bus agents will deassert their outputs within two clocks. RESET# must not be kept asserted for more than 10ms. A number of bus signals are sampled at the active-to-inactive transition of RESET# for power-on configuration. These configuration options are described in the Section 6.1. This signal does not have on-die termination and must be terminated at the end agent. See the appropriate Platform Design Guideline for additional information.	4
RS[2:0]#	ı	RS[2:0]# (Response Status) are driven by the response agent (the agent responsible for completion of the current transaction), and must connect the appropriate pins of all processor front side bus agents.	4
RSP#	I	RSP# (Response Parity) is driven by the response agent (the agent responsible for completion of the current transaction) during assertion of RS[2:0]#, the signals for which RSP# provides parity protection. It must connect to the appropriate pins of all processor front side bus agents. A correct parity signal is high if an even number of covered signals are low and low if an odd number of covered signals are low. While RS[2:0]# = 000, RSP# is also high, since this indicates it is not being driven by any agent guaranteeing correct parity.	4
SKTOCC#	0	SKTOCC# (Socket occupied) will be pulled to ground by the processor to indicate that the processor is present.	
SLP#	ı	SLP# (Sleep), when asserted in Stop-Grant state, causes processors to enter the Sleep state. During Sleep state, the processor stops providing internal clock signals to all units, leaving only the Phase-Locked Loop (PLL) still operating. Processors in this state will not recognize snoops or interrupts. The processor will recognize only assertion of the RESET# signal, deassertion of SLP#, and removal of the BCLK input while in Sleep state. If SLP# is deasserted, the processor exits Sleep state and returns to Stop-Grant state, restarting its internal clock signals to the bus and processor core units.	3
SMB_PRT	I	Pin is grounded on processor packages that do not contain SMBUS components (PIROM, Scratch EEPROM, and thermal sensor). It is floating on processor packages that contain the SMBus components.	



Table 41. Signal Definitions (Sheet 8 of 9)

Service interrupts while in Stop-Grant state. When STPCLK# is deasserted, the processor restarts its internal clock to all units and resumes execution. The assertion of STPCLK# has no effect on the bus clock; STPCLK# is an asynchronous input. TCK I TCK (Test Clock) provides the clock input for the processor Test Bus (also known as the Test Access Port). TDI (Test Data In) transfers serial test data into the processor. TDI provides the serial input needed for JTAG specification support. TDO (Test Data Out) transfers serial test data out of the processor. TDO provides the serial output needed for JTAG specification support. All TESTHI[6:0] pins should be individually connected to VCC via a pull-up resistor which matches the trace impedance within a range of ±10 ohms. TESTHI[3:0] and TESTHI[6:5] may all be tied together and pulled up to VCC with a single resistor if desired. However, utilization of boundary scan test will not be functional if these pins are connected together. TESTHI4 must always be pulled up independently from the other TESTHI pins. For optimum noise margin, all pull-up resistor values used for TESTHI[6:0] pins should have a resistance value within ±20 percent of the impedance of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω, then a value between 40 Ω and 60 Ω should be used. The TESTHI[6:0] termination recommendations provided in the Intel® Xeon TM processor datasheet are still suitable for the Intel® Xeon TM processor with 533 MHz Front Side Bus. However, Intel recommends new designs or designs undergoing design updates follow the trace impedance matching termination guidelines given in this section. Activation of THERMTRIP# (Thermal Trip) indicates the processor junction temperature has reached a level beyond which permanent silicon damage may occur. Measurement of the temperature is accomplished through an internal thermal sensor which is configured to trip at approximately 135 °C. To properly protect the processor, power must be removed upon THE	Name	Type	Description	Notes		
SMI# I issued, and the processor begins program execution from the SMM handler. If SMI# is asserted during the deassertion of RESET# the processor will tri-state its outputs.	SMI#					
issued, and the processor begins program execution from the SMM handler. If SM# is asserted during the deassertion of RESET# the processor will tri-state its outputs. STPCLK# (Stop Clock), when asserted, causes processors to enter a low power Stop-Grant state. The processor issues a Stop-Grant Acknowledge transaction, and stops providing internal clock signals to all processor core units except the from the processor restarts its internal clock to all units and resures execution. The assertion of STPCLK# has no effect on the bus clock; STPCLK# is an asynchronous input. TCK (Test Clock) provides the clock input for the processor Test Bus (also known as the Test Access Port). TDI (Test Data In) transfers serial test data into the processor. TDI provides the serial input needed for JTAG specification support. TDO O TDO (Test Data Out) transfers serial test data out of the processor. TDO provides the serial output needed for JTAG specification support. All TESTHI[6:0] pins should be individually connected to VCC via a pull-up resistor which matches the trace impedance within a range of ±10 ohms. TESTHI[3:0] and TESTHI[6:1] pins should be individually connected to VCC with a single resistor if desired. However, utilization of boundary scan test will not be functional if these pins are connected together. TESTHI4 must always be pulled up independently from the other TESTHI pins. For optimum noise margin, all pull-up resistor values used for TESTHI[6:0] pins should have a resistance value within ±20 percent of the TESTHI[6:0] pins should have a resistance value within ±20 percent of the mediance of the baseboard transmission line traces. For example, the trace impedance of the baseboard transmission line traces. For example, the trace impedance was some processor with 533 MHz Front Side Bus. However, Intel recommendations provided in the Intel® Xeon TM processor datasheet are still suitable for the Intel® Xeon TM processor with 533 MHz Front Side Bus. However, Intel recommendations provided in the Intel® Xeon			and enter System Management Mode (SMM). An SMI Acknowledge transaction is			
outputs. STPCLK# (Stop Clock), when asserted, causes processors to enter a low power Stop-Grant state. The processor issues a Stop-Grant Acknowledge transaction, and stops providing internal clock signals to all processor core units except the front side bus and APIC units. The processor continues to snoop bus transactions and stops providing internal clock signals to all processor core units except the front side bus and APIC units. The processor continues to snoop bus transactions and service interrupts while in Stop-Grant state. When STPCLK# is deasserted, the processor restarts its internal clock to all units and resumes execution. The assertion of STPCLK# has no effect on the bus clock; STPCLK# is an asynchronous input. TCK (Test Clock) provides the clock input for the processor Test Bus (also known as the Test Access Port). TDI (Test Data In) transfers serial test data into the processor. TDO provides the serial input needed for JTAG specification support. TDO (Test Data Clut) transfers serial test data out of the processor. TDO provides the serial output needed for JTAG specification support. All TESTHI[6:0] pins should be individually connected to VCC via a pull-up resistor which matches the trace impedance within a range of ±10 ohms. TESTHI[3:0] and TESTHI[6:0] pins should have a resistance value within ±20 percent of the simpedance of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω, then a value between 40 Ω and 60 Ω should be used. The TESTHI[6:0] prins should have a resistance value within ±20 percent of the Interpretation of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω, then a value between 40 Ω and 60 Ω should be used. The TESTHI[6:0] prins should have a resistance value within ±20 percent of the Interpretation provided in the Intel® Xeon Processor datashed are still suitable for the Intel® Xeon Processor with 533 MHz Front Side Bus. However, Intel recommendations provided in the Intel® Xeon Processor datashed are sti	SIVII#	ı	issued, and the processor begins program execution from the SMM handler.	3		
STPCLK# (Stop Clock), when asserted, causes processors to enter a low power Stop-Grant state. The processor issues a Stop-Grant Acknowledge transaction, and stops providing internal clock signals to all processor core units except the front side bus and APIC units. The processor continues to snoop bus transactions and service interrupts while in Stop-Grant state. When STPCLK# is deasserted, the processor restarts its internal clock to all units and resumes execution. The assertion of STPCLK# has no effect on the bus clock; STPCLK# is an asynchronous input. TCK			If SMI# is asserted during the deassertion of RESET# the processor will tri-state its			
Stop-Grant state. The processor issues a Stop-Grant Acknowledge transaction, and stops providing internal clock signals to all processor core units except the front side bus and APIC units. The processor core units except the front side bus and APIC units. The processor continues to snoop bus transactions and service interrupts while in Stop-Grant state. When STPCLK# is deasserted, the processor restarts its internal clock to all units and resumes execution. The assertion of STPCLK# has no effect on the bus clock; STPCLK# is an asynchronous input. TCK 1 TCK (Test Clock) provides the clock input for the processor Test Bus (also known as the Test Access Port). TDI (Test Data In) transfers serial test data into the processor. TDI provides the serial input needed for JTAG specification support. TDO TDO (Test Data Out) transfers serial test data out of the processor. TDO provides the serial output needed for JTAG specification support. All TESTHI[6:0] pins should be individually connected to VCC via a pull-up resistor which matches the trace impedance within a range of ±10 hms. TESTHI[3:0] and TESTHI[6:0] may all be tied together and pulled up to VCC with a single resistor if desired. However, utilization of boundary scan test will not be functional if these pins are connected together. TESTHI4 must always be pulled up independently from the other TESTHI[6:0] pins should have a resistance value within ±20 percent of the impedance of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω, then a value between 40 Ω and 60 Ω should be used. The TESTHI[6:0] termination recommendations provided in the Intel® Xeon TM processor with 533 MHz Front Side Bus. However, Intel recommends new designs or designs undergoing design updates follow the trace impedance matching termination guidelines given in this section. Activation of THERMTRIP# (Thermal Trip) indicates the processor junction temperature has reached a level beyond which permanent silicon damage may occur. Measurement of the t			outputs.			
TDI (Test Data In) transfers serial test data into the processor. TDI provides the serial input needed for JTAG specification support. TDO (Test Data Out) transfers serial test data out of the processor. TDO provides the serial output needed for JTAG specification support. All TESTHI[6:0] pins should be individually connected to VCC via a pull-up resistor which matches the trace impedance within a range of ±10 ohms. TESTHI[3:0] and TESTHI[6:5] may all be tied together and pulled up to VCC with a single resistor if desired. However, utilization of boundary scan test will not be functional if these pins are connected together. TESTHI4 must always be pulled up independently from the other TESTHIF pins. For optimum noise margin, all pull-up resistor values used for TESTHI[6:0] pins should have a resistance value within ±20 percent of the impedance of the baseboard transmission line traces. For example, if the trace impedance of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω, then a value between 40 Ω and 60 Ω should be used. The TESTHI[6:0] termination recommendations provided in the Intel® Xeon TM processor datasheet are still suitable for the Intel® Xeon TM processor with 533 MHz Front Side Bus. However, Intel recommends new designs or designs undergoing design updates follow the trace impedance matching termination guidelines given in this section. Activation of THERMTRIP# (Thermal Trip) indicates the processor junction temperature has reached a level beyond which permanent silicon damage may occur. Measurement of the temperature is accomplished through an internal thermal sensor which is configured to trip at approximately 135 °C. To properly protect the processor, power must be removed upon THERMTRIP# becoming active. See Figure 6 for the appropriate power down sequence and timing requirement. In parallel, the processor will attempt to reduce its temperature by shutting off internal clocks and stopping all program execution. Once activated, THERMTRIP# remains latched	STPCLK#	I	Stop-Grant state. The processor issues a Stop-Grant Acknowledge transaction, and stops providing internal clock signals to all processor core units except the front side bus and APIC units. The processor continues to snoop bus transactions and service interrupts while in Stop-Grant state. When STPCLK# is deasserted, the processor restarts its internal clock to all units and resumes execution. The assertion of STPCLK# has no effect on the bus clock; STPCLK# is an			
TDO O TDO (Test Data Out) transfers serial test data out of the processor. TDO provides the serial output needed for JTAG specification support. All TESTHI[6:0] pins should be individually connected to VCC via a pull-up resistor which matches the trace impedance within a range of ±10 ohms. TESTHI[3:0] and TESTHI[6:5] may all be tied together and pulled up to VCC with a single resistor if desired. However, utilization of boundary scan test will not be functional if these pins are connected together. TESTHI4 must always be pulled up independently from the other TESTHI pins. For optimum noise margin, all pull-up resistor values used for TESTHI[6:0] pins should have a resistance value within ±20 percent of the impedance of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω, then a value between 40 Ω and 60 Ω should be used. The TESTHI[6:0] termination recommendations provided in the Intel® Xeon TM processor datasheet are still suitable for the Intel® Xeon TM processor with 533 MHz Front Side Bus. However, Intel recommends new designs or designs undergoing design updates follow the trace impedance matching termination guidelines given in this section. Activation of THERMTRIP# (Thermal Trip) indicates the processor junction temperature has reached a level beyond which permanent silicon damage may occur. Measurement of the temperature is accomplished through an internal thermal sensor which is configured to trip at approximately 135 °C. To properly protect the processor, power must be removed upon THERMTRIP# becoming active. See Figure 6 for the appropriate power down sequence and timing requirement. In parallel, the processor will attempt to reduce its temperature by shutting off internal clocks and stopping all program execution. Once activated, THERMTRIP# remains latched and the processor will be stopped until RESET# is asserted. A RESET# pulse will reset the processor will be stopped until RESET# is asserted. A RESET# so activated even if the processor is still to hot hot. T	TCK	I				
the serial output needed for JTAG specification support. All TESTHI[6:0] pins should be individually connected to VCC via a pull-up resistor which matches the trace impedance within a range of ±10 ohms. TESTHI[3:0] and TESTHI[6:5] may all be tied together and pulled up to VCC with a single resistor if desired. However, utilization of boundary scan test will not be functional if these pins are connected together. TESTHI4 must always be pulled up independently from the other TESTHI[6:0] pins should have a resistance value within ±20 percent of the impedance of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω, then a value between 40 Ω and 60 Ω should be used. The TESTHI[6:0] termination recommendations provided in the Intel® Xeon TM processor datasheet are still suitable for the Intel® Xeon TM processor with 533 MHz Front Side Bus. However, Intel recommends new designs or designs undergoing design updates follow the trace impedance matching termination guidelines given in this section. Activation of THERMTRIP# (Thermal Trip) indicates the processor junction temperature has reached a level beyond which permanent silicon damage may occur. Measurement of the temperature is accomplished through an internal thermal sensor which is configured to trip at approximately 135 °C. To properly protect the processor, power must be removed upon THERMTRIP# becoming active. See Figure 6 for the appropriate power down sequence and timing requirement. In parallel, the processor will attempt to reduce its temperature by shutting off internal clocks and stopping all program execution. Once activated, THERMTRIP# remains latched and the processor will be stopped until RESET# is asserted. A RESET# pulse will reset the processor and execution will begin at the boot vector. If the temperature has not dropped below the trip level, the processor will assert THERMTRIP# and return to the shutdown state. The processor releases THERMTRIP# when RESET# is activated even if the processor is still too hot. T	TDI	I				
which matches the trace impedance within a range of ±10 ohms. TESTHI[3:0] and TESTHI[6:5] may all be tied together and pulled up to VCC with a single resistor if desired. However, utilization of boundary scan test will not be functional if these pins are connected together. TESTHI4 must always be pulled up independently from the other TESTHI pins. For optimum noise margin, all pull-up resistor values used for TESTHI[6:0] pins should have a resistance value within ±20 percent of the impedance of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω, then a value between 40 Ω and 60 Ω should be used. The TESTHI[6:0] termination recommendations provided in the Intel® Xeon TM processor datasheet are still suitable for the Intel® Xeon TM processor with 533 MHz Front Side Bus. However, Intel recommends new designs or designs undergoing design updates follow the trace impedance matching termination guidelines given in this section. Activation of THERMTRIP# (Thermal Trip) indicates the processor junction temperature has reached a level beyond which permanent silicon damage may occur. Measurement of the temperature is accomplished through an internal thermal sensor which is configured to trip at approximately 135 °C. To properly protect the processor, power must be removed upon THERMTRIP# becoming active. See Figure 6 for the appropriate power down sequence and timing requirement. In parallel, the processor will attempt to reduce its temperature by shutting off internal clocks and stopping all program execution. Once activated, THERMTRIP# remains latched and the processor will be stopped until RESET# is asserted. A RESET# pulse will reset the processor and execution will begin at the boot vector. If the temperature has not dropped below the trip level, the processor will assert THERMTRIP# and return to the shutdown state. The processor releases THERMTRIP# when RESET# is activated even if the processor is still too hot. This signal do not have on-die termination and must be terminated a	TDO	0				
temperature has reached a level beyond which permanent silicon damage may occur. Measurement of the temperature is accomplished through an internal thermal sensor which is configured to trip at approximately 135 °C. To properly protect the processor, power must be removed upon THERMTRIP# becoming active. See Figure 6 for the appropriate power down sequence and timing requirement. In parallel, the processor will attempt to reduce its temperature by shutting off internal clocks and stopping all program execution. Once activated, THERMTRIP# remains latched and the processor will be stopped until RESET# is asserted. A RESET# pulse will reset the processor and execution will begin at the boot vector. If the temperature has not dropped below the trip level, the processor will assert THERMTRIP# and return to the shutdown state. The processor releases THERMTRIP# when RESET# is activated even if the processor is still too hot. This signal do not have on-die termination and must be terminated at the end agent. See the appropriate platform design guidelines for additional	TESTHI[6:0]	ı	which matches the trace impedance within a range of ± 10 ohms. TESTHI[3:0] and TESTHI[6:5] may all be tied together and pulled up to VCC with a single resistor if desired. However, utilization of boundary scan test will not be functional if these pins are connected together. TESTHI4 must always be pulled up independently from the other TESTHI pins. For optimum noise margin, all pull-up resistor values used for TESTHI[6:0] pins should have a resistance value within ± 20 percent of the impedance of the baseboard transmission line traces. For example, if the trace impedance is 50 Ω , then a value between 40 Ω and 60 Ω should be used. The TESTHI[6:0] termination recommendations provided in the Intel® Xeon TM processor datasheet are still suitable for the Intel® Xeon TM processor with 533 MHz Front Side Bus. However, Intel recommends new designs or designs undergoing design updates follow the trace impedance matching termination guidelines given			
	THERMTRIP#	0	temperature has reached a level beyond which permanent silicon damage may occur. Measurement of the temperature is accomplished through an internal thermal sensor which is configured to trip at approximately 135 °C. To properly protect the processor, power must be removed upon THERMTRIP# becoming active. See Figure 6 for the appropriate power down sequence and timing requirement. In parallel, the processor will attempt to reduce its temperature by shutting off internal clocks and stopping all program execution. Once activated, THERMTRIP# remains latched and the processor will be stopped until RESET# is asserted. A RESET# pulse will reset the processor and execution will begin at the boot vector. If the temperature has not dropped below the trip level, the processor will assert THERMTRIP# and return to the shutdown state. The processor releases THERMTRIP# when RESET# is activated even if the processor is still too hot. This signal do not have on-die termination and must be terminated at the end agent. See the appropriate platform design guidelines for additional	2		
THERMDA O Thermal Diode Anode.	THERMDA	0	Thermal Diode Anode.			
THERMDC O Thermal Diode Cathode.	THERMDC	0	Thermal Diode Cathode.			



Table 41. Signal Definitions (Sheet 9 of 9)

Name	Type	Description				
TMS	ı	TMS (Test Mode Select) is a JTAG specification support signal used by debug tools. This signal does not have on-die termination and must be terminated at the end agent. See the appropriate platform design guidelines for additional				
		information.				
TRDY#	ı	RDY# (Target Ready) is asserted by the target to indicate that it is ready to receive write or implicit writeback data transfer. TRDY# must connect the appropriate pins all front side bus agents.				
TRST#	ı	TRST# (Test Reset) resets the Test Access Port (TAP) logic. TRST# must be driven low during power on Reset. See the appropriate Platform Design Guideline for additional information.				
V _{CCA}	I	VCCA provides isolated power for the analog portion of the internal PLL's. Use a discrete RLC filter to provide clean power. Use the filter defined in Section 2.5 to provide clean power to the PLL. The tolerance and total ESR for the filter is important. Refer to the appropriate platform design guidelines for complete implementation details.				
V _{CCIOPLL}	I	V_{CCIOPLL} provides isolated power for digital portion of the internal PLL's. Follow the guidelines for V_{CCA} (Section 2.5), and refer to the appropriate platform design guidelines for complete implementation details.				
V _{CCSENSE} V _{SSSENSE}	0	The Vccsense and Vsssense pins are the points for which processor minimum and maximum voltage requirements are specified. Uniprocessor designs may utilize these pins for voltage sensing for the processor's voltage regulator. However, multiprocessor designs must not connect these pins to sense logic, but rather utilize them for power delivery validation.				
VID[4:0]	0	VID[4:0] (Voltage ID) pins can be used to support automatic selection of power supply voltages (V_{CC}). Unlike previous processor generations, these pins are driven by processor logic. Hence the voltage supply for these pins (SM_ V_{CC}) must be valid before the VRM supplying Vcc to the processor is enabled. Conversely, the VRM output must be disabled prior to the voltage supply for these pins becomes invalid. The VID pins are needed to support processor voltage specification variations. See Table 3 for definitions of these pins. The power supply must supply the voltage that is requested by these pins, or disable itself.				
VID_VCC .	I	Voltage for VID and BSEL logic				
V_{SSA}	I	V_{SSA} provides an isolated, internal ground for internal PLL's. Do not connect directly to ground. This pin is to be connected to V_{CCA} and $V_{CCIOPLL}$ through a discrete filter circuit.				

- 1. Intel Xeon processors only support BR0# and BR1#. However, the Intel Xeon processors must terminate BR2# and BR3# to the
- processor V_{CC.}
 2. For this pin on Intel[®] Xeon™ processors, the maximum number of symmetric agents is one. Maximum number of Central Agents is zero.
- 3. For this pin on Intel[®] Xeon™ processors, the maximum number of symmetric agents is two. Maximum number of Central Agents is zero.
- 4. For this pin on Intel[®] Xeon™ processors, the maximum number of symmetric agents is two. Maximum number of Central Agents is one.



5.0 Thermal Specifications

This chapter provides the thermal specifications necessary for designing a thermal solution for the Intel® XeonTM Processor with 533 MHz Front Side Bus. Thermal solutions should include heatsinks that attach to the integrated heat spreader (IHS). The IHS provides a common interface intended to be compatible with many heatsink designs. Thermal specifications are based on the temperature of the IHS top, referred to as the case temperature, or T_{CASE} . Thermal solutions should be designed to maintain the processor within T_{CASE} specifications. For information on performing T_{CASE} measurements, refer to the Intel® Xeon T^{M} Processor Thermal Design Guidelines. See Figure 18 for an exploded view of the processor package and thermal solution assembly.

Note: The processor is either shipped alone or with a heatsink (boxed processor only). All other components shown in Figure 18 must be purchased separately.

Heat sink clip

Heat sink

EMI ground
frame

Retention
mechanism

604 Pin
socket

Figure 18. Processor with Thermal and Mechanical Components - Exploded View

Note: This is a graphical representation. For specifications, see each component's respective documentation listed in Section 1.3.



5.1 Thermal Specifications

To allow for the optimal operation and long-term reliability of Intel processor-based systems, the system/processor thermal solution should be designed such that the processor remains between the minimum and maximum case temperature (TC) specifications when operating at or below the Thermal Design Power (TDP) value listed per frequency in Table 42. Thermal solutions not designed to provide this level of thermal capability may affect the long-term reliability of the processor and system. For more details on thermal solution design, please refer to the appropriate processor thermal design guidelines.

The case temperature is defined at the geometric top center of the processor IHS. Analysis indicates that real applications are unlikely to cause the processor to consume maximum power dissipation for sustained periods of time. Intel recommends that complete thermal solution designs target the Thermal Design Power (TDP) indicated in Table 42 instead of the maximum processor power consumption. The Thermal Monitor feature is intended to help protect the processor in the unlikely event that an application exceeds the TDP recommendation for a sustained period of time. For more details on the usage of this feature, refer to Section 6.3. To ensure maximum flexibility for future requirements, systems should be designed to the Flexible Motherboard Guidelines (FMB), even if a processor with a lower thermal dissipation is currently planned. In all cases, the Thermal Monitor feature must be enabled for the processor to remain within specification

Toble 42	Drocock	Thormal	Decian	Dower
Table 42.	Processor '	ı nermai	Design	Power

Core Frequency	L2 Cache (KB)	L3 Cache (MB)	Processor Signature	Thermal Design Power ¹ (W)	Maximum Power (W)	Minimum TCASE (°C)	Maximum TCASE (°C)	Notes
2 GHz	512			58	66	5	70	2,3
2.40 GHz	512		0F27h	65	75	5	74	2,3
2.66 GHz	512		or	72	83	5	74	2,3
2.80 GHz	512		0F29h	74	86	5	75	2,3
3.06 GHz	512			85	101	5	73	2,3
2.40 GHz	512		0F25h	77	86	5	72	2,3
2.66 GHz	512			77	86	5	72	2,3
2.80 GHz	512			77	86	5	72	2,3
3.06 GHz	512	1		87	102	5	70	2,3
3.20 GHz	512	1		92	110	5	71	2,3
3.20 GHz	512	2		92	110	5	71	2,3

NOTE:

- Intel recommends that thermal solutions be designed utilizing the Thermal Design Power values. Refer to the Intel® Xeon™ Processor Thermal Design Guidelines.
- 2. TDP values are specified at the point on Vcc_max loadline corresponding to Icc_TDP.
- Systems must be designed to ensure that the processor is not subjected to any static Vcc and Icc
 combination wherein Vcc exceeds Vcc_max at specified Icc. Please refer to the loadline specifications in
 Chapter 2.0.



Figure 19. Processor Thermal Design Power vs Electrical Projections for VID = 1.500V

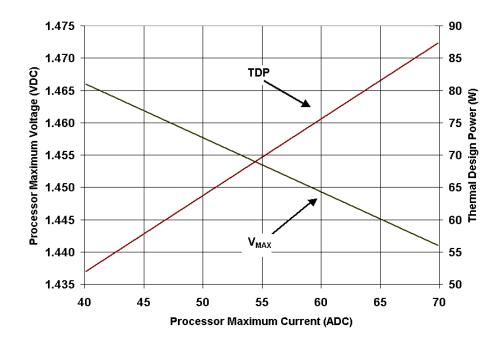
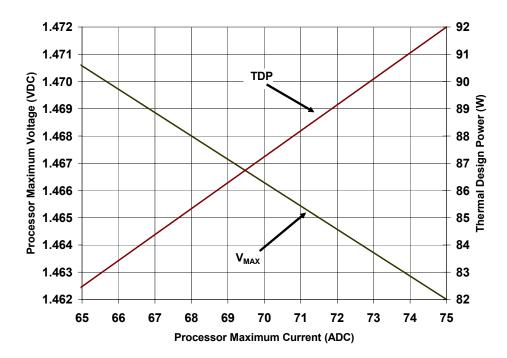




Figure 20. Processor Thermal Design Power vs Electrical Projections for VID = 1.525V



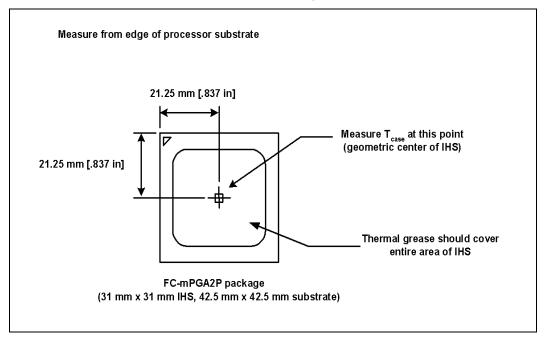


5.2 Measurements for Thermal Specifications

5.2.1 Processor Case Temperature Measurement

The maximum and minimum case temperature (TCASE) for the Intel Xeon Processor is specified in Table 33. This temperature specification is meant to help ensure proper operation of the processor. Figure 21 illustrates where Intel recommends TCASE thermal measurements should be made

Figure 21. Thermal Measurement Point for Processor T_{CASE}



Note: Figure is not to scale, and is for reference only





6.0 Features

6.1 Power-On Configuration Options

The Intel[®] XeonTM Processor with 533 MHz Front Side Bus has several configuration options that are determined by the state of specific processor pins at the active-to-inactive transition of the processor RESET# signal. These configuration options cannot be changed except by another reset. Both power on and software induced resets reconfigure the processor(s).

Table 43. Power-On Configuration Option Pins

Configuration Option	Pin ¹	Notes
Output tri state	SMI#	
Execute BIST (Built-In Self Test)	INIT#	
In Order Queue de-pipelining (set IOQ depth to 1)	A7#	
Disable MCERR# observation	A9#	
Disable BINIT# observation	A10#	
APIC cluster ID (0-3)	A[12:11]#	2
Disable bus parking	A15#	
Disable Hyper-Threading Technology	A31#	
Symmetric agent arbitration ID	BR[3:0]#	3

NOTES:

- 1. Asserting this signal during active-to-inactive edge of RESET# will selects the corresponding option.
- 2. The Intel® Xeon™ processor with 533 MHz Front Side Bus does not support this feature, therefore platforms utilizing this processor should not use these configuration pins.
- 3. Intel Xeon processor with 533 MHz Front Side Bus utilize only BR0# and BR1# signals. 2-way platforms must not utilize BR2# and BR3# signals.

6.2 Clock Control and Low Power States

The processor allows the use of AutoHALT, Stop-Grant and Sleep states to reduce power consumption by stopping the clock to internal sections of the processor, depending on each particular state. See Figure 22 for a visual representation of the processor low power states.

Due to the inability of processors to recognize bus transactions during the Sleep state, multiprocessor systems are not allowed to simultaneously have one processor in Sleep state and the other processor in the Normal or Stop-Grant state.

6.2.1 Normal State—State 1

This is the normal operating state for the processor.

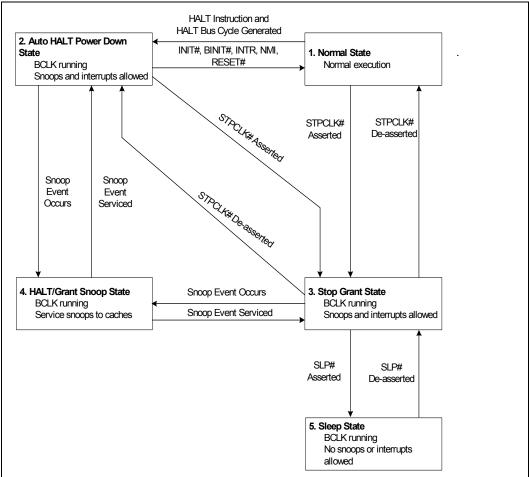


6.2.2 AutoHALT Powerdown State—State 2

AutoHALT is a low power state entered when the processor executes the HALT instruction. The processor will transition to the Normal state upon the occurrence of BINIT#, INIT#, LINT[1:0] (NMI, INTR), or an interrupt delivered over the front side bus. RESET# will cause the processor to immediately initialize itself.

The system can generate a STPCLK# while the processor is in the AutoHALT Power Down state. When the system deasserts the STPCLK# interrupt, the processor will return execution to the HALT state.

Figure 22. Stop Clock State Machine



6.2.3 Stop-Grant State—State 3

When the STPCLK# pin is asserted, the Stop-Grant state of the processor is entered 20 bus clocks after the response phase of the processor-issued Stop Grant Acknowledge special bus cycle. Once the STPCLK# pin has been asserted, it may only be deasserted once the processor is in the Stop Grant state. Both logical processors of the Intel® XeonTM processor with 533 MHz Front Side Bus must be in the Stop Grant state before the deassertion of STPCLK#.



Since the AGTL+ signal pins receive power from the front side bus, these pins should not be driven (allowing the level to return to V_{CC}) for minimum power drawn by the termination resistors in this state. In addition, all other input pins on the front side bus should be driven to the inactive state.

BINIT# will be recognized while the processor is in Stop-Grant state. If STPCLK# is still asserted at the completion of the BINIT# bus initialization, the processor will remain in Stop-Grant mode. If the STPCLK# is not asserted at the completion of the BINIT# bus initialization, the processor will return to Normal state.

RESET# will cause the processor to immediately initialize itself, but the processor will stay in Stop-Grant state. A transition back to the Normal state will occur with the deassertion of the STPCLK# signal. When re-entering the Stop-Grant state from the sleep state, STPCLK# should only be deasserted one or more bus clocks after the deassertion of SLP#.

A transition to the HALT/Grant Snoop state will occur when the processor detects a snoop on the front side bus (see Section 6.2.4). A transition to the Sleep state (see Section 6.2.5) will occur with the assertion of the SLP# signal.

While in the Stop-Grant state, INIT#, BINIT# and LINT[1:0] will be latched by the processor, and only serviced when the processor returns to the Normal state. Only one occurrence of each event will be recognized upon return to the Normal state.

6.2.4 HALT/Grant Snoop State—State 4

The processor will respond to snoop transactions on the front side bus while in Stop-Grant state or in AutoHALT Power Down state. During a snoop transaction, the processor enters the HALT/Grant Snoop state. The processor will stay in this state until the snoop on the front side bus has been serviced (whether by the processor or another agent on the front side bus). After the snoop is serviced, the processor will return to the Stop-Grant state or AutoHALT Power Down state, as appropriate.

6.2.5 Sleep State—State 5

The Sleep state is a very low power state in which each processor maintains its context, maintains the phase-locked loop (PLL), and has stopped most of internal clocks. The Sleep state can only be entered from Stop-Grant state. Once in the Stop-Grant state, the SLP# pin can be asserted, causing the processor to enter the Sleep state. The SLP# pin is not recognized in the Normal or AutoHALT states.

Snoop events that occur while in Sleep state or during a transition into or out of Sleep state will cause unpredictable behavior.

In the Sleep state, the processor is incapable of responding to snoop transactions or latching interrupt signals. No transitions or assertions of signals (with the exception of SLP# or RESET#) are allowed on the front side bus while the processor is in Sleep state. Any transition on an input signal before the processor has returned to Stop-Grant state will result in unpredictable behavior.

If RESET# is driven active while the processor is in the Sleep state, and held active as specified in the RESET# pin specification, then the processor will reset itself, ignoring the transition through Stop-Grant state. If RESET# is driven active while the processor is in the Sleep state, the SLP# and STPCLK# signals should be deasserted immediately after RESET# is asserted to ensure the processor correctly executes the reset sequence.



Once in the Sleep state, the SLP# pin can be deasserted if another asynchronous front side bus event occurs. The SLP# pin should only be asserted when the processor (and all logical processors within the physical processor) is in the Stop-Grant state. SLP# assertions while the processors are not in the Stop-Grant state is out of specification and may result in illegal operation.

6.2.6 Bus Response During Low Power States

While in AutoHALT Power Down and Stop-Grant states, the processor will process a front side bus snoop.

When the processor is in Sleep state, the processor will not process interrupts or snoop transactions.

6.3 Thermal Monitor

The Thermal Monitor feature helps control the processor temperature by activating the Thermal Control Circuit (TCC) when the processor silicon reaches its maximum operating temperature. The TCC reduces processor power consumption by modulating (starting and stopping) the internal processor core clocks. The Thermal Monitor feature must be enabled for the processor to be operating within specifications. The temperature at which Thermal Monitor activates the thermal control circuit is not user configurable and is not software visible. Bus traffic is snooped in the normal manner, and interrupt requests are latched (and serviced during the time that the clocks are on) while the TCC is active.

When the Thermal Monitor feature is enabled, and a high temperature situation exists (i.e. TCC is active), the clocks will be modulated by alternately turning the clocks off and on at a duty cycle specific to the processor (typically 30-50%). Clocks often will not be off for more than 3.0 microseconds when the TCC is active. Cycle times are processor speed dependent and will decrease as processor core frequencies increase. A small amount of hysteresis has been included to prevent rapid active/inactive transitions of the TCC when the processor temperature is near its maximum operating temperature. Once the temperature has dropped below the maximum operating temperature, and the hysteresis timer has expired, the TCC goes inactive and clock modulation ceases.

With a properly designed and characterized thermal solution, it is anticipated that the TCC would only be activated for very short periods of time when running the most power intensive applications. The processor performance impact due to these brief periods of TCC activation is expected to be so minor that it would be immeasurable. An under-designed thermal solution that is not able to prevent excessive activation of the TCC in the anticipated ambient environment may cause a noticeable performance loss, and in some cases may result in a TC that exceeds the specified maximum temperature and may affect the long-term reliability of the processor. In addition, a thermal solution that is significantly under-designed may not be capable of cooling the processor even when the TCC is active continuously. Refer to the Intel Xeon Processor Thermal Design Guidelines for information on designing a thermal solution.

The duty cycle for the TCC, when activated by the Thermal Monitor, is factory configured and cannot be modified. The Thermal Monitor does not require any additional hardware, software drivers, or interrupt handling routines.

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6.3.1 Thermal Diode

The processor incorporates an on-die thermal diode. A thermal sensor located on the baseboard may be used to monitor the die temperature of the processor for thermal management/long term die temperature change purposes. Table 44 and Table 45 provide the diode parameter and interface specifications. This thermal diode is separate from the Thermal Monitor's thermal sensor and cannot be used to predict the behavior of the Thermal Monitor.

Table 44. Thermal Diode Parameters

Symbol	Parameter	Min	Тур	Max	Unit	Notes
I_{FW}	Forward Bias Current	5		300	uA	1
n	Diode Ideality Factor	1.0011	1.0021	1.0030		2,3,4
R _T	Series Resistance		3.64		W	2,3,5

NOTES:

- 1. Intel does not support or recommend operation of the thermal diode under reverse bias.
- 2. Characterized at 75°C.
- 3. Not 100% tested. Specified by design characterization.
- 4. The ideality factor, n, represents the deviation from ideal diode behavior as exemplified by the diode equation:

 $I_{FW}=I_s*(e^{(qVD/nkT)}-1)$

Where l_S = saturation current, q = electronic charge, V_D = voltage across the diode, k = Boltzmann Constant, and T = absolute temperature (Kelvin).

5. The series resistance, R_T, is provided to allow for a more accurate measurement of the diode junction temperature. R_T as defined includes the pins of the processor but does not include any socket resistance or board trace resistance between the socket and the external remote diode thermal sensor. R_T can be used by remote diode thermal sensors with automatic series resistance cancellation to calibrate out this error term. Another application is that a temperature offset can be manually calculated and programmed into an offset register in the remote diode thermal sensors as exemplified by the equation: T_{error} = [R_T*(N-1)*I_{FWmin}]/[(nk/q)*ln N]

Where T_{error} = sensor temperature error, N = sensor current ration, k = Boltzmann Constant, q = electronic charge.

Table 45. Thermal Diode Interface

Pin Name	Pin Number	Pin Description
THERMDA	Y27	diode anode
THERMDC	Y28	diode cathode





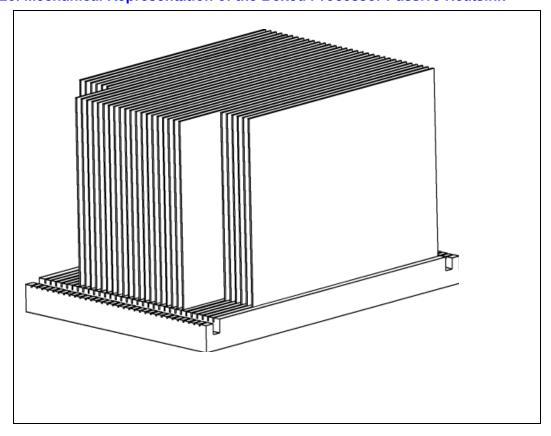
7.0 Boxed Processor Specifications

7.1 Introduction

The Intel® XeonTM Processor with 533 MHz Front Side Bus is also offered as an Intel boxed processor. Intel boxed processors are intended for system integrators who build systems from components available through distribution channels. The boxed processor is supplied with an unattached passive heatsink. It will also contain an optional active duct solution, called Processor Wind Tunnel (PWT), to provide adequate airflow across the heatsink. If the chassis or baseboard used contains an alternate cooling solution that has been thermally validated, the PWT may be discarded. This chapter documents baseboard and platform requirements for the cooling solution that is supplied with the boxed processor. This chapter is particularly important for OEM's that manufacture baseboards and chassis for integrators. Figure 23 shows a mechanical representation of a boxed processor heatsink.

Note: Drawings in this section reflect only the specifications on the Intel boxed processor product. These dimensions should not be used as a generic keep-out zone for all cooling solutions. It is the system designer's responsibility to consider their proprietary cooling solution when designing to the required keep-out zone on their system platform and chassis.

Figure 23. Mechanical Representation of the Boxed Processor Passive Heatsink





7.2 Mechanical Specifications

This section documents the mechanical specifications of the boxed processor passive heatsink and the PWT.

Proper clearance is required around the heatsink to ensure proper installation of the processor and unimpeded airflow for proper cooling.

7.2.1 Boxed Processor Heatsink Dimensions

The boxed processor is shipped with an unattached passive heatsink. Clearance is required around the heatsink to ensure unimpeded airflow for proper cooling. The physical space requirements and dimensions for the boxed processor with assembled heatsink are shown in Figure 26 (Multiple Views). The airflow requirements for the boxed processor heatsink must also be taken into consideration when designing new baseboards and chassis. The airflow requirements are detailed in the Thermal Specifications, Section 7.4.

7.2.2 Boxed Processor Heatsink Weight

The boxed processor heatsink weighs no more than 450 grams. See Chapter 3.0 and Chapter 5.0 of this document along with the *Intel*[®] *Xeon TM Processor Family Thermal Design Guidelines* for details on the processor weight and heatsink requirements.

7.2.3 Boxed Processor Retention Mechanism and Heatsink Supports

The boxed processor requires processor retention solution to secure the processor, the baseboard, and the chassis. The retention solution contains one retention mechanisms and two retention clips per processor. The boxed processor ships with retention mechanism, cooling solution retention clips, and direct chassis attach screws. Baseboards and chassis designed for use by system integrators should include holes that are in proper alignment with each other to support the boxed processor. Refer to the Server System Infrastructure Specification (SSI-EEB) at http://www.ssiforum.org for details on the hole locations. Please refer to the "Boxed integration notes" at http://support.intel.com/support/processors/xeon for retention mechanism installation instructions. Retention mechanism clips must interface with the boxed processor heatsink area shown in Detail A in Figure 26.

The retention mechanism that ships with the boxed processor is different than the reference solution from Intel. Please refer to Figure 24 below, which contains the dimensions for the reference solution. Please refer to Figure 25 for the retention mechanism that ships with the boxed processor.



MOTES:

1. ALL DIMENSIONS ARE IN MILLIMETERS.

2. TOLERANCES +/- .25.

Figure 24. Boxed Processor Retention Mechanism and Clip



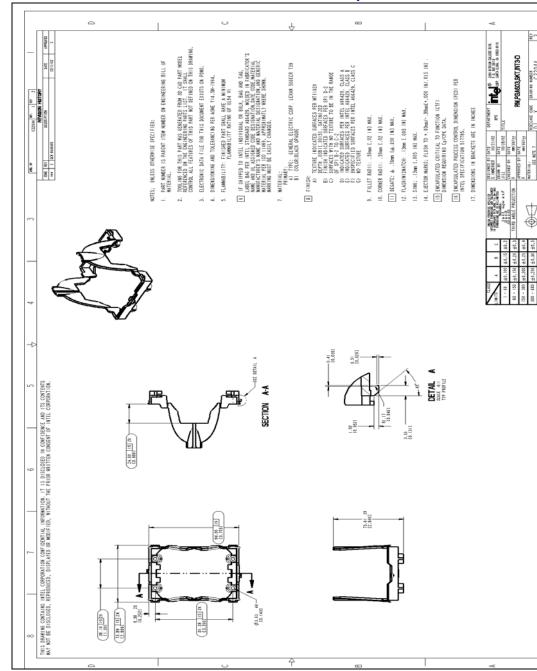


Figure 25. Boxed Processor Retention Mechanism that Ships with the Processor



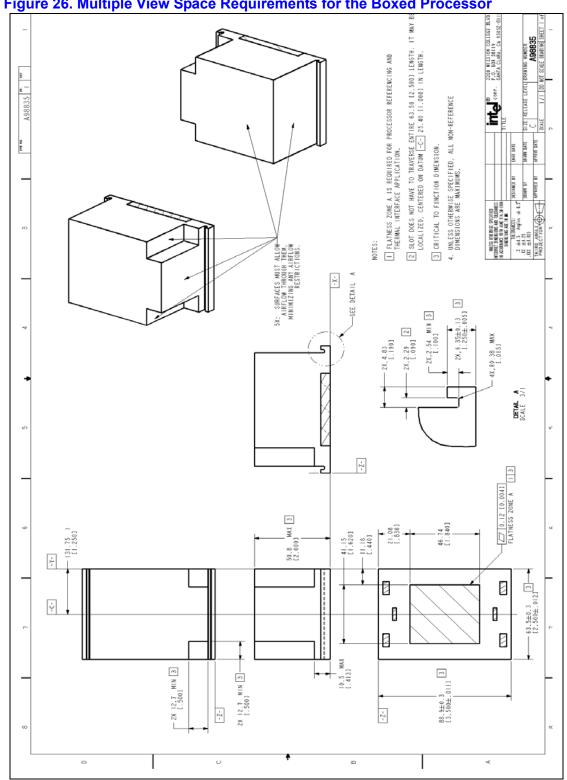


Figure 26. Multiple View Space Requirements for the Boxed Processor



7.3 Boxed Processor Requirements

7.3.1 Intel® Xeon™ Processor with 533 MHz Front Side Bus

7.3.1.1 Processor Wind Tunnel

The boxed processor ships with an active duct cooling solution called the Processor Wind Tunnel, or PWT. This is an optional cooling solution that is designed to meet the thermal requirements of a diverse combination of baseboards and chassis. It ships with the processor in order to reduce the burden on the chassis manufacturer to provide adequate airflow across the processor heatsink. Manufacturers may elect to use their own cooling solution.

Note: Although Intel will be testing a select number of baseboard and chassis combinations for thermal compliance, this is in no way a comprehensive test. It is ultimately the system integrator's responsibility to test that their solution meets all of the requirements specified in this document. The PWT is meant to assist in processor cooling, but additional cooling techniques may be required in order to ensure that the entire system meets the thermal requirements.

See Figure 28 and Figure 29 for the Processor Wind Tunnel dimensions.

7.3.1.2 Fan Power Supply

The Processor Wind Tunnel includes a fan, which requires a constant +12V power supply. A fan power cable is shipped with the boxed processor to draw power from a power header on the baseboard. The power cable connector and pinouts are shown in Figure 27 and the fan cable connector requirements are detailed in Table 46. Platforms must provide a matched power header to support the boxed processor. Table 47 contains specifications for the input and output signals at the fan heatsink connector. The fan heatsink outputs a SENSE signal, an open-collector output, that pulses at a rate of two pulses per fan revolution. A baseboard pull-up resistor provides V_{OH} to match the baseboard-mounted fan speed monitor requirements, if applicable. Use of the SENSE signal is optional. If the SENSE signal is not used, pin 3 of the connector should be tied to GND.

The power header on the baseboard must be positioned to allow the fan heatsink power cable to reach it. The power header identification and location should be documented in the platform documentation, or on the baseboard itself. The baseboard power header should be positioned within 7 inches from the centre of the processor socket.



Figure 27. Fan Connector Electrical Pin Sequence

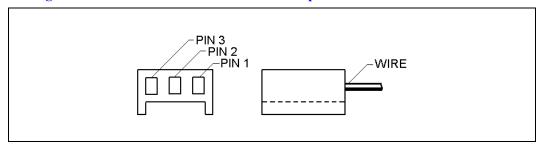


Table 46. Fan Cable Connector Requirements

Item	Specification
Connector Type	 Fan connector must be a straight square pin, 3-pin terminal housing with polarizing ribs and friction locking ramp. Match with a straight pin, friction lock header on the mainboard. Manufacturer and part number or equivalent: AMP[†]: Fan connector: 643815-3, header: 640456-3 Walden[†] / Molex[†]: Fan connector: 22-01-3037, header: 22-23-2031
Pin Out (See Figure Above)	 Pin 1: Ground; black wire. Pin 2: Power, +12 V; yellow wire. Pin 3: Signal, Open collector tachometer output signal requirement: 2 pulses per revolution; green wire.
Fan cable length (Drawing 747887):	The fan cable connector must reach a mating mainboard connector at any point within a radius of 110 mm (4.33") measured from the central datum planes of the enabled assembly (datum planes A, B & C on Drawing AXXXXX).
Fan cable routing	Fan power cable must be routed in such a way to prevent it from contacting the fan impellor and it must be positioned in a consistent location from unit to unit.

Table 47. Fan Power and Signal Specifications

Description	Min	Тур	Max	Unit	Notes
+12V: 12 Vot Fan Power Supply	6.0	12.0	13.2	V	_
IC: Fan Current Draw			1.5	Α	
SENSE Frequency		2		Pulses per fan revolution	1

^{1.} Baseboard should pull this pin up to $\ensuremath{V_{\text{CC}}}$ with a resistor.



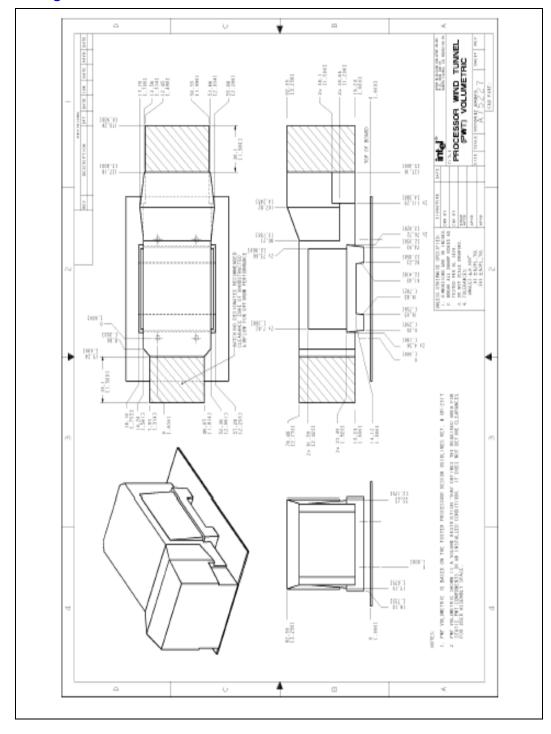


Figure 28. Processor Wind Tunnel General Dimensions



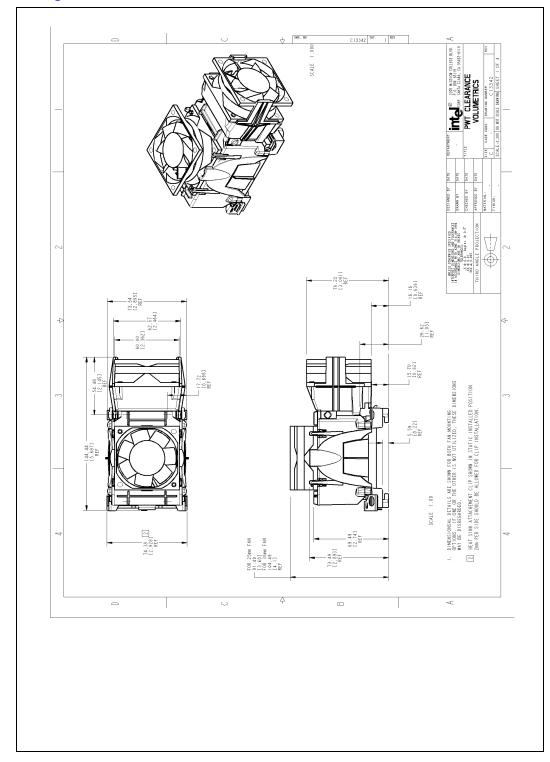


Figure 29. Processor Wind Tunnel Detailed Dimensions



7.3.1.3 Fan

The Processor Wind Tunnel includes a 25mm fan for use with processors <= 2.8 GHz, or a 38mm fan for use with processors running at 3 GHz and above. The 38mm fan provides the high performance required to meet the demanding thermal requirements of processors running at 3 GHz and above. The 38mm fan provides local fan speed control. There is a temperature diode on the fan that measures the inlet temperature to the fan and adjusts the speed accordingly. The benefit is that system manufacturers can pass acoustical requirements while still being able to pass thermal requirements at maximum ambient temperature.

7.3.2 1U Rack Mount Server Solution

The 1U solution contains a passive heatsink and a foam pad, in addition to the retention solution included with the other options. Because of the small form factor, the 1U heatsink is not as efficient at dissipating heat as the general-purpose heatsink. In order to ensure maximum thermal efficiency, the foam pad must be attached to the top of the 1U heatsink, blocking airflow between the heatsink and the chassis cover. This will force air through the heatsink fins instead of allowing it to bypass over the top. See Figure 30 and Figure 31 for more detail on installation.

Figure 30. Exploded View of the 1U Thermal Solution

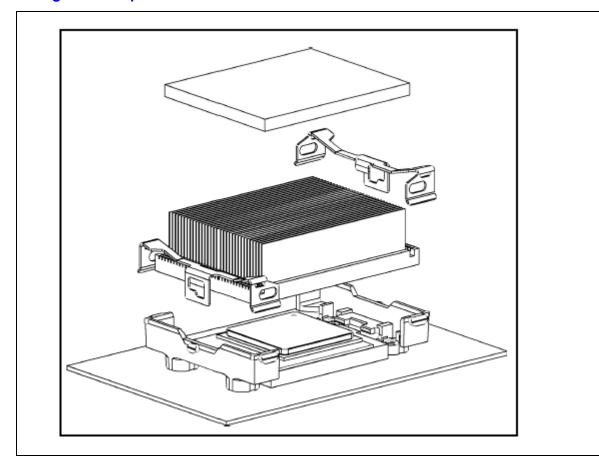
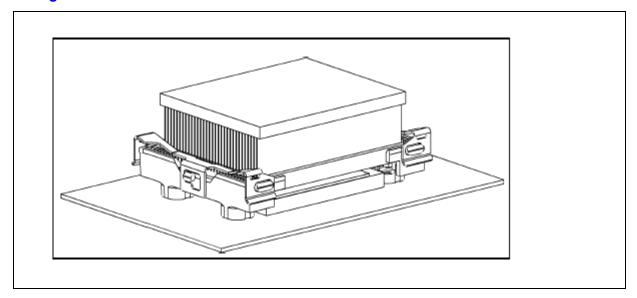




Figure 31. Assembled View of the 1U Thermal Solution





7.4 Thermal Specifications

This section describes the cooling requirements of the heatsink solution utilized by the boxed processor.

7.4.1 Boxed Processor Cooling Requirements

The boxed processor will be directly cooled with a passive heatsink. For the passive heatsink to effectively cool the boxed processor, it is critical that sufficient, unimpeded, cool air flow over the heatsink of every processor in the system. Meeting the processor's temperature specification is a function of the thermal design of the entire system, and ultimately the responsibility of the system integrator. The processor temperature specification is found in Chapter 5.0. It is important that system integrators perform thermal tests to verify that the boxed processor is kept below its maximum temperature specification in a specific baseboard and chassis.

At an absolute minimum, the boxed processor heatsink will require 500 Linear Feet per Minute (LFM) of cool air flowing over the heatsink. The airflow must be directed from the outside of the chassis directly over the processor heatsinks in a direction passing from one retention mechanism to the other. It also should flow from the front to the back of the chassis. Directing air over the passive heatsink of the boxed Intel® XeonTM Processor with 533 MHz Front Side Bus can be done with auxiliary chassis fans, fan ducts, or other techniques.

It is also recommended that the ambient air temperature outside of the chassis be kept at or below 35 °C. The air passing directly over the processor heatsink should not be preheated by other system components (such as another processor), and should be kept at or below 45 °C. Again, meeting the processor's temperature specification is the responsibility of the system integrator. The processor temperature specification is found in Chapter 5.0.



8.0 Debug Tools Specifications

The Debug Port design information has been moved. This includes all information necessary to develop a Debug Port on this platform, including electrical specifications, mechanical requirements, and all In-Target Probe (ITP) signal layout guidelines. Please reference the *ITP700 Debug Port Design Guide* for the design of your platform.

8.1 Logic Analyzer Interface (LAI)

Intel® is working with two logic analyzer vendors to provide logic analyzer interfaces (LAIs) for use in debugging systems. Tektronix* and Agilent* should be contacted to get specific information about their logic analyzer interfaces. The following information is general in nature. Specific information must be obtained from the logic analyzer vendor.

Due to the complexity of systems, the LAI is critical in providing the ability to probe and capture front side bus signals. There are two sets of considerations to keep in mind when designing a system that can make use of an LAI: mechanical and electrical.

8.1.1 Mechanical Considerations

The LAI is installed between the processor socket and the processor. The LAI pins plug into the socket, while the processor pins plug into a socket on the LAI. Cabling that is part of the LAI egresses the system to allow an electrical connection between the processor and a logic analyzer. The maximum volume occupied by the LAI, known as the keepout volume, as well as the cable egress restrictions, should be obtained from the logic analyzer vendor. System designers must make sure that the keepout volume remains unobstructed inside the system. Note that it is possible that the keepout volume reserved for the LAI may differ from the space normally occupied by the processor heatsink. If this is the case, the logic analyzer vendor will provide a cooling solution as part of the LAI.

8.1.2 Electrical Considerations

The LAI will also affect the electrical performance of the front side bus; therefore, it is critical to obtain electrical load models from each of the logic analyzers to be able to run system level simulations to prove that their tool will work in the system. Contact the logic analyzer vendor for electrical specifications and load models for the LAI solution they provide.

